

**$\mu$ PD42S16165L, 4216165L****3.3 V OPERATION 16 M-BIT DYNAMIC RAM  
1 M-WORD BY 16-BIT, EDO, BYTE READ/WRITE MODE,****Description**

The  $\mu$ PD42S16165L, 4216165L are 1,048,576 words by 16 bits CMOS dynamic RAMs with optional EDO.

EDO is a kind of the page mode and is useful for the read operation.

Besides, the  $\mu$ PD42S16165L can execute  $\overline{\text{CAS}}$  before  $\overline{\text{RAS}}$  self refresh.

The  $\mu$ PD42S16165L, 4216165L are packaged in 50-pin plastic TSOP (II) and 42-pin plastic SOJ.

**Features**

- EDO (Hyper page mode)
- 1,048,576 words by 16 bits organization
- Single +3.3 V  $\pm 0.3$  V power supply
- Fast access and cycle time

| Part number                         | Power consumption<br>Active (MAX.) | Access time<br>(MAX.) | R/W cycle time<br>(MIN.) | EDO (Hyper page mode)<br>cycle time (MIN.) |
|-------------------------------------|------------------------------------|-----------------------|--------------------------|--------------------------------------------|
| $\mu$ PD42S16165L-A50, 4216165L-A50 | 432 mW                             | 50 ns                 | 84 ns                    | 20 ns                                      |
| $\mu$ PD42S16165L-A60, 4216165L-A60 | 396 mW                             | 60 ns                 | 104 ns                   | 25 ns                                      |
| $\mu$ PD42S16165L-A70, 4216165L-A70 | 360 mW                             | 70 ns                 | 124 ns                   | 30 ns                                      |

- The  $\mu$ PD42S16165L can execute  $\overline{\text{CAS}}$  before  $\overline{\text{RAS}}$  self refresh

| Part number       | Refresh cycle       | Refresh                                                                                                                                                                                         | Power consumption at standby<br>(MAX.) |
|-------------------|---------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|----------------------------------------|
| $\mu$ PD42S16165L | 4,096 cycles/128 ms | $\overline{\text{CAS}}$ before $\overline{\text{RAS}}$ self refresh,<br>$\overline{\text{CAS}}$ before $\overline{\text{RAS}}$ refresh,<br>$\overline{\text{RAS}}$ only refresh, Hidden refresh | 0.54 mW<br>(CMOS level input)          |
| $\mu$ PD4216165L  | 4,096 cycles/64 ms  | $\overline{\text{CAS}}$ before $\overline{\text{RAS}}$ refresh,<br>$\overline{\text{RAS}}$ only refresh,<br>Hidden refresh                                                                      | 1.8 mW<br>(CMOS level input)           |

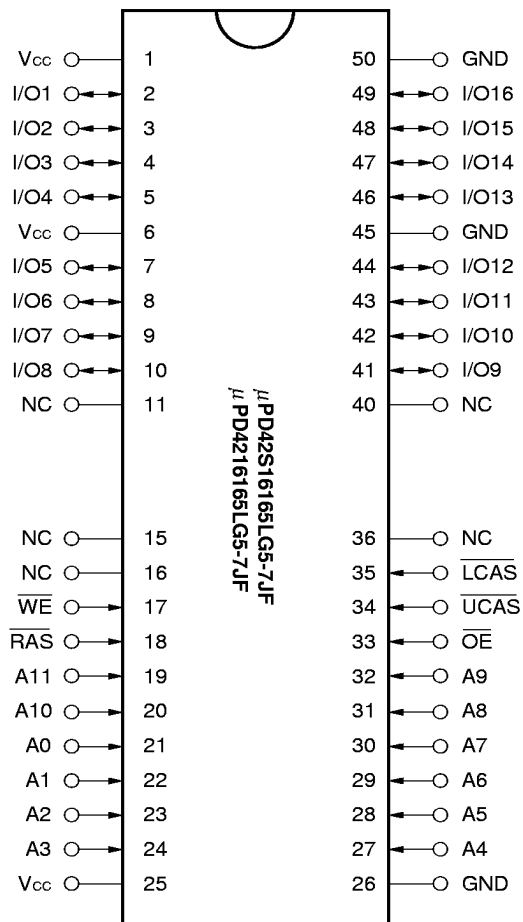
The information in this document is subject to change without notice.

## ★ Ordering Information

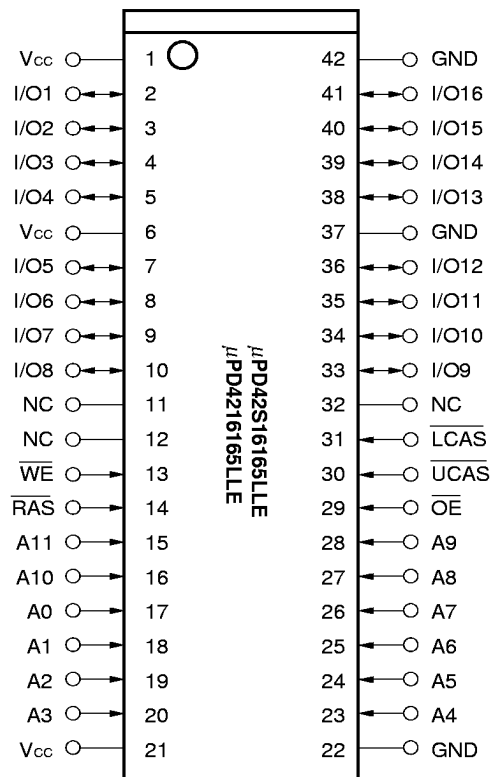
| Part number                 | Access time<br>(MAX.) | Package                               | Refresh                                                             |
|-----------------------------|-----------------------|---------------------------------------|---------------------------------------------------------------------|
| $\mu$ PD42S16165LG5-A50-7JF | 50 ns                 | 50-pin plastic TSOP (II)<br>(400 mil) | $\overline{\text{CAS}}$ before $\overline{\text{RAS}}$ self refresh |
| $\mu$ PD42S16165LG5-A60-7JF | 60 ns                 |                                       | $\overline{\text{CAS}}$ before $\overline{\text{RAS}}$ refresh      |
| $\mu$ PD42S16165LG5-A70-7JF | 70 ns                 |                                       | $\overline{\text{RAS}}$ only refresh                                |
| $\mu$ PD42S16165LLE-A50     | 50 ns                 | 42-pin plastic SOJ<br>(400 mil)       | Hidden refresh                                                      |
| $\mu$ PD42S16165LLE-A60     | 60 ns                 |                                       |                                                                     |
| $\mu$ PD42S16165LLE-A70     | 70 ns                 |                                       |                                                                     |
| $\mu$ PD4216165LG5-A50-7JF  | 50 ns                 | 50-pin plastic TSOP (II)<br>(400 mil) | $\overline{\text{CAS}}$ before $\overline{\text{RAS}}$ refresh      |
| $\mu$ PD4216165LG5-A60-7JF  | 60 ns                 |                                       | $\overline{\text{RAS}}$ only refresh                                |
| $\mu$ PD4216165LG5-A70-7JF  | 70 ns                 |                                       | Hidden refresh                                                      |
| $\mu$ PD4216165LLE-A50      | 50 ns                 | 42-pin plastic SOJ<br>(400 mil)       |                                                                     |
| $\mu$ PD4216165LLE-A60      | 60 ns                 |                                       |                                                                     |
| $\mu$ PD4216165LLE-A70      | 70 ns                 |                                       |                                                                     |

Pin Configurations (Marking Side)

50-pin Plastic TSOP (II) (400 mil)

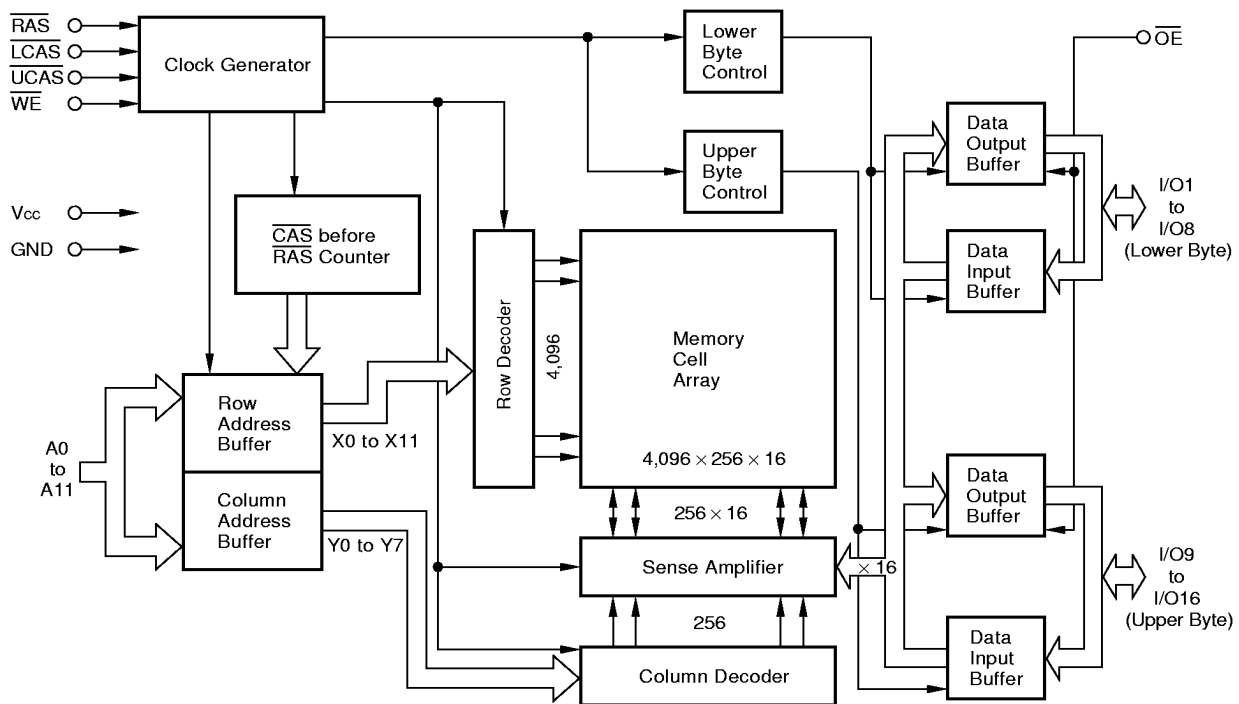


42-pin Plastic SOJ (400 mil)



- A0 to A11 : Address Inputs
- I/O1 to I/O16 : Data Inputs/Outputs
- RAS : Row Address Strobe
- UCAS : Column Address Strobe (upper)
- LCAS : Column Address Strobe (lower)
- WE : Write Enable
- OE : Output Enable
- V<sub>CC</sub> : Power Supply
- GND : Ground
- NC : No Connection

# Block Diagram



# Input/Output Pin Functions

The μPD42S16165L, 4216165L have input pins  $\overline{\text{RAS}}$ ,  $\overline{\text{CAS}}$ <sup>Note</sup>,  $\overline{\text{WE}}$ ,  $\overline{\text{OE}}$ , A0 to A11 and input/output pins I/O1 to I/O16.

| Pin name                                           | Input/Output | Function                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                 |
|----------------------------------------------------|--------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| $\overline{\text{RAS}}$<br>(Row address strobe)    | Input        | $\overline{\text{RAS}}$ activates the sense amplifier by latching a row address and selecting a corresponding word line.<br>It refreshes memory cell array of one line selected by the row address.<br>It also selects the following function.<br><ul style="list-style-type: none"> <li>• <math>\overline{\text{CAS}}</math> before <math>\overline{\text{RAS}}</math> refresh</li> </ul>                                                                                                                                                                                                                                                                                                                                                                               |
| $\overline{\text{CAS}}$<br>(Column address strobe) |              | $\overline{\text{CAS}}$ activates data input/output circuit by latching column address and selecting a digit line connected with the sense amplifier.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                    |
| A0 to A11<br>(Address inputs)                      |              | Address bus.<br>Input total 20-bit of address signal, upper 12-bit and lower 8-bit in sequence (address multiplex method).<br>Therefore, one word is selected from 1,048,576-word by 16-bit memory cell array.<br>In actual operation, latch row address by specifying row address and activating $\overline{\text{RAS}}$ .<br>Then, switch the address bus to column address and activate $\overline{\text{CAS}}$ .<br>Each address is taken into the device when $\overline{\text{RAS}}$ and $\overline{\text{CAS}}$ are activated.<br>Therefore, the address input setup time ( $t_{\text{ASR}}$ , $t_{\text{ASC}}$ ) and hold time ( $t_{\text{RAH}}$ , $t_{\text{CAH}}$ ) are specified for the activation of $\overline{\text{RAS}}$ and $\overline{\text{CAS}}$ . |
| $\overline{\text{WE}}$<br>(Write enable)           |              | Write control signal.<br>Write operation is executed by activating $\overline{\text{RAS}}$ , $\overline{\text{CAS}}$ and $\overline{\text{WE}}$ .                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                        |
| $\overline{\text{OE}}$<br>(Output enable)          |              | Read control signal.<br>Read operation can be executed by activating $\overline{\text{RAS}}$ , $\overline{\text{CAS}}$ and $\overline{\text{OE}}$ .<br>If $\overline{\text{WE}}$ is activated during read operation, $\overline{\text{OE}}$ is to be ineffective in the device.<br><br>Therefore, read operation cannot be executed.                                                                                                                                                                                                                                                                                                                                                                                                                                     |
| I/O1 to I/O16<br>(Data inputs/outputs)             | Input/Output | 16-bit data bus.<br>I/O1 to I/O16 are used to input/output data.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                         |

**Note**  $\overline{\text{CAS}}$  means  $\overline{\text{UCAS}}$  and  $\overline{\text{LCAS}}$ .

## Hyper Page Mode (EDO)

The hyper page mode (EDO) is a kind of page mode with enhanced features. The two major features of the hyper page mode (EDO) are as follows.

### 1. Data output time is extended.

In the hyper page mode (EDO), the output data is held to the next  $\overline{\text{CAS}}$  cycle's falling edge, instead of the rising edge. For this reason, valid data output time in the hyper page mode (EDO) is extended compared with the fast page mode (= data extend function). In the fast page mode, the data output time becomes shorter as the  $\overline{\text{CAS}}$  cycle time becomes shorter. Therefore, in the hyper page mode (EDO), the timing margin in read cycle is larger than that of the fast page mode even if the  $\overline{\text{CAS}}$  cycle time becomes shorter.

### 2. The $\overline{\text{CAS}}$ cycle time in the hyper page mode (EDO) is shorter than that in the fast page mode.

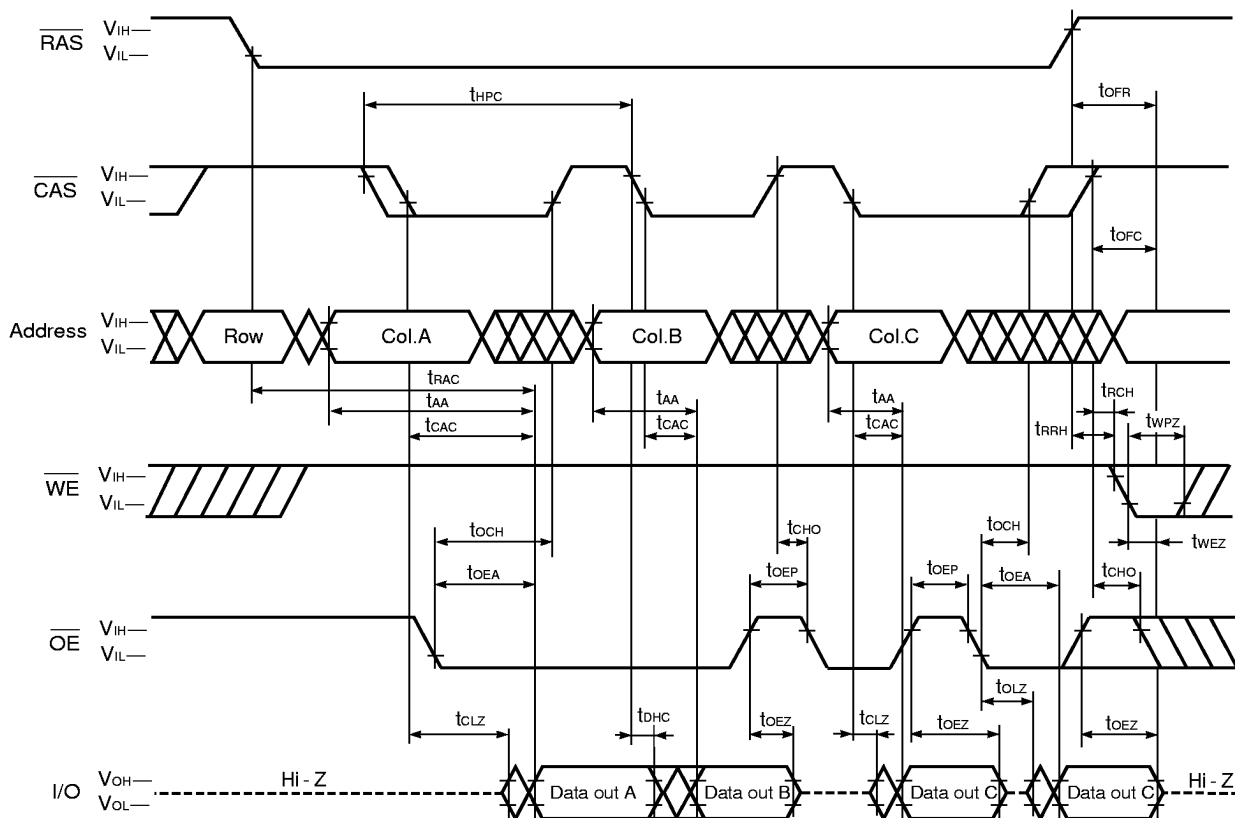
In the hyper page mode (EDO), due to the data extend function, the  $\overline{\text{CAS}}$  cycle time can be shorter than in the fast page mode if the timing margin is the same.

Taking a device whose  $t_{\text{RAC}}$  is 60 ns as an example, the  $\overline{\text{CAS}}$  cycle time in the fast page mode is 25 ns while that in the fast page mode is 40 ns.

In the hyper page mode (EDO), read (data out) and write (data in) cycles can be executed repeatedly during one  $\overline{\text{RAS}}$  cycle. The hyper page mode (EDO) allows both read and write operations during one cycle.

The following shows a part of the hyper page mode (EDO) read cycle. Specifications to be observed are described in the next page.

Hyper Page Mode (EDO) Read Cycle



**Cautions when using the hyper page mode (EDO)**

1.  $\overline{\text{CAS}}$  access should be used to operate  $t_{\text{HPC}}$  at the MIN. value.
2. To make I/Os to Hi-Z in read cycle, it is necessary to control  $\overline{\text{RAS}}$ ,  $\overline{\text{CAS}}$ ,  $\overline{\text{WE}}$ ,  $\overline{\text{OE}}$  as follows. The effective specification depends on the state of each signal.
  - (1) Both  $\overline{\text{RAS}}$  and  $\overline{\text{CAS}}$  are inactive (at the end of read cycle)
 

$\overline{\text{WE}}$ : inactive,  $\overline{\text{OE}}$ : active

$t_{\text{OFC}}$  is effective when  $\overline{\text{RAS}}$  is inactivated before  $\overline{\text{CAS}}$  is inactivated.

$t_{\text{OFR}}$  is effective when  $\overline{\text{CAS}}$  is inactivated before  $\overline{\text{RAS}}$  is inactivated.

The slower of  $t_{\text{OFC}}$  and  $t_{\text{OFR}}$  becomes effective.
  - (2) Both  $\overline{\text{RAS}}$  and  $\overline{\text{CAS}}$  are active or either  $\overline{\text{RAS}}$  or  $\overline{\text{CAS}}$  is active (in read cycle)
 

$\overline{\text{WE}}$ ,  $\overline{\text{OE}}$ : inactive .....  $t_{\text{OEZ}}$  is effective.

Both  $\overline{\text{RAS}}$  and  $\overline{\text{CAS}}$  are inactive or  $\overline{\text{RAS}}$  is active and  $\overline{\text{CAS}}$  is inactive (at the end of read cycle)

$\overline{\text{WE}}$ ,  $\overline{\text{OE}}$ : active and either  $t_{\text{RRH}}$  or  $t_{\text{RCH}}$  must be met .....  $t_{\text{WEZ}}$  and  $t_{\text{WPZ}}$  are effective.

The faster of  $t_{\text{OEZ}}$  and  $t_{\text{WEZ}}$  becomes effective.

The faster of (1) and (2) becomes effective.
3. In read cycle, the effective specification depends on the state of  $\overline{\text{CAS}}$  signal when controlling data output with the  $\overline{\text{OE}}$  signal.
  - (1)  $\overline{\text{CAS}}$ : inactive,  $\overline{\text{OE}}$ : active .....  $t_{\text{CHO}}$  is effective.
  - (2)  $\overline{\text{CAS}}$ ,  $\overline{\text{OE}}$ : active .....  $t_{\text{OCH}}$  is effective.

## Electrical Specifications

- $\overline{\text{CAS}}$  means  $\overline{\text{UCAS}}$  and  $\overline{\text{LCAS}}$ .
- All voltages are referenced to GND.
- After power up ( $V_{CC} \geq V_{CC(\text{MIN.})}$ ), wait more than 100  $\mu\text{s}$  ( $\overline{\text{RAS}}$ ,  $\overline{\text{CAS}}$  inactive) and then, execute eight  $\overline{\text{CAS}}$  before  $\overline{\text{RAS}}$  or  $\overline{\text{RAS}}$  only refresh cycles as dummy cycles to initialize internal circuit.

## Absolute Maximum Ratings

| Parameter                          | Symbol           | Condition | Rating       | Unit               |
|------------------------------------|------------------|-----------|--------------|--------------------|
| Voltage on any pin relative to GND | $V_T$            |           | −0.5 to +4.6 | V                  |
| Supply voltage                     | $V_{CC}$         |           | −0.5 to +4.6 | V                  |
| Output current                     | $I_O$            |           | 20           | mA                 |
| Power dissipation                  | $P_D$            |           | 1            | W                  |
| Operating ambient temperature      | $T_A$            |           | 0 to +70     | $^{\circ}\text{C}$ |
| Storage temperature                | $T_{\text{stg}}$ |           | −55 to +125  | $^{\circ}\text{C}$ |

**Caution** Exposing the device to stress above those listed in Absolute Maximum Ratings could cause permanent damage. The device is not meant to be operated under conditions outside the limits described in the operational section of this specification. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability.

## Recommended Operating Conditions

| Parameter                     | Symbol   | Condition | MIN. | TYP. | MAX.           | Unit               |
|-------------------------------|----------|-----------|------|------|----------------|--------------------|
| Supply voltage                | $V_{CC}$ |           | 3.0  | 3.3  | 3.6            | V                  |
| High level input voltage      | $V_{IH}$ |           | 2.0  |      | $V_{CC} + 0.3$ | V                  |
| Low level input voltage       | $V_{IL}$ |           | −0.3 |      | +0.8           | V                  |
| Operating ambient temperature | $T_A$    |           | 0    |      | 70             | $^{\circ}\text{C}$ |

## Capacitance ( $T_A = 25^{\circ}\text{C}$ , $f = 1\text{ MHz}$ )

| Parameter                     | Symbol    | Test condition                                                                                      | MIN. | TYP. | MAX. | Unit |
|-------------------------------|-----------|-----------------------------------------------------------------------------------------------------|------|------|------|------|
| Input capacitance             | $C_{I1}$  | Address                                                                                             |      |      | 5    | pF   |
|                               | $C_{I2}$  | $\overline{\text{RAS}}$ , $\overline{\text{CAS}}$ , $\overline{\text{WE}}$ , $\overline{\text{OE}}$ |      |      | 7    |      |
| Data input/output capacitance | $C_{I/O}$ | I/O                                                                                                 |      |      | 7    | pF   |

## ★ DC Characteristics (Recommended operating conditions unless otherwise noted)

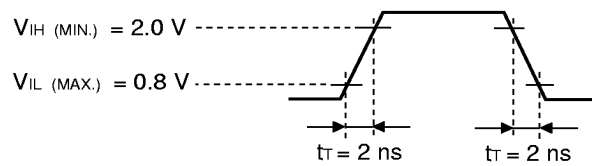
| Parameter                                                                                                                                         |                                                                                                       | Symbol             | Test condition                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                               |                                      | MIN. | MAX. | Unit          | Notes      |
|---------------------------------------------------------------------------------------------------------------------------------------------------|-------------------------------------------------------------------------------------------------------|--------------------|----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|--------------------------------------|------|------|---------------|------------|
| Operating current                                                                                                                                 |                                                                                                       | I <sub>CC1</sub>   | $\overline{\text{RAS}}, \overline{\text{CAS}}$ cycling<br>$t_{\text{RC}} = t_{\text{RC (MIN.)}}, I_o = 0 \text{ mA}$                                                                                                                                                                                                                                                                                                                                                                                                                         | $t_{\text{RAC}} = 50 \text{ ns}$     |      | 110  | mA            | 1, 2, 3    |
|                                                                                                                                                   |                                                                                                       |                    |                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              | $t_{\text{RAC}} = 60 \text{ ns}$     |      | 90   |               |            |
|                                                                                                                                                   |                                                                                                       |                    |                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              | $t_{\text{RAC}} = 70 \text{ ns}$     |      | 80   |               |            |
| Standby current                                                                                                                                   | $\mu\text{PD42S16165L}$                                                                               | I <sub>CC2</sub>   | $\overline{\text{RAS}}, \overline{\text{CAS}} \geq V_{\text{IH (MIN.)}}, I_o = 0 \text{ mA}$                                                                                                                                                                                                                                                                                                                                                                                                                                                 |                                      |      | 0.5  | mA            |            |
|                                                                                                                                                   | $\overline{\text{RAS}}, \overline{\text{CAS}} \geq V_{\text{CC}} - 0.2 \text{ V}, I_o = 0 \text{ mA}$ |                    |                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              | 0.15                                 |      |      |               |            |
|                                                                                                                                                   | $\mu\text{PD4216165L}$                                                                                |                    | $\overline{\text{RAS}}, \overline{\text{CAS}} \geq V_{\text{IH (MIN.)}}, I_o = 0 \text{ mA}$                                                                                                                                                                                                                                                                                                                                                                                                                                                 |                                      |      | 2.0  |               |            |
|                                                                                                                                                   |                                                                                                       |                    | $\overline{\text{RAS}}, \overline{\text{CAS}} \geq V_{\text{CC}} - 0.2 \text{ V}, I_o = 0 \text{ mA}$                                                                                                                                                                                                                                                                                                                                                                                                                                        |                                      |      | 0.5  |               |            |
| $\overline{\text{RAS}}$ only refresh current                                                                                                      |                                                                                                       | I <sub>CC3</sub>   | $\overline{\text{RAS}}$ cycling, $\overline{\text{CAS}} \geq V_{\text{IH (MIN.)}}$<br>$t_{\text{RC}} = t_{\text{RC (MIN.)}}, I_o = 0 \text{ mA}$                                                                                                                                                                                                                                                                                                                                                                                             | $t_{\text{RAC}} = 50 \text{ ns}$     |      | 110  | mA            | 1, 2, 3, 4 |
|                                                                                                                                                   |                                                                                                       |                    |                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              | $t_{\text{RAC}} = 60 \text{ ns}$     |      | 90   |               |            |
|                                                                                                                                                   |                                                                                                       |                    |                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              | $t_{\text{RAC}} = 70 \text{ ns}$     |      | 80   |               |            |
| Operating current<br>(Hyper page mode (EDO))                                                                                                      |                                                                                                       | I <sub>CC4</sub>   | $\overline{\text{RAS}} \leq V_{\text{IL (MAX.)}}, \overline{\text{CAS}}$ cycling<br>$t_{\text{HPC}} = t_{\text{HPC (MIN.)}}, I_o = 0 \text{ mA}$                                                                                                                                                                                                                                                                                                                                                                                             | $t_{\text{RAC}} = 50 \text{ ns}$     |      | 120  | mA            | 1, 2, 5    |
|                                                                                                                                                   |                                                                                                       |                    |                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              | $t_{\text{RAC}} = 60 \text{ ns}$     |      | 110  |               |            |
|                                                                                                                                                   |                                                                                                       |                    |                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              | $t_{\text{RAC}} = 70 \text{ ns}$     |      | 100  |               |            |
| $\overline{\text{CAS}}$ before $\overline{\text{RAS}}$<br>refresh current                                                                         |                                                                                                       | I <sub>CC5</sub>   | $\overline{\text{RAS}}$ cycling<br>$t_{\text{RC}} = t_{\text{RC (MIN.)}}, I_o = 0 \text{ mA}$                                                                                                                                                                                                                                                                                                                                                                                                                                                | $t_{\text{RAC}} = 50 \text{ ns}$     |      | 110  | mA            | 1, 2       |
|                                                                                                                                                   |                                                                                                       |                    |                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              | $t_{\text{RAC}} = 60 \text{ ns}$     |      | 90   |               |            |
|                                                                                                                                                   |                                                                                                       |                    |                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              | $t_{\text{RAC}} = 70 \text{ ns}$     |      | 80   |               |            |
| $\overline{\text{CAS}}$ before $\overline{\text{RAS}}$<br>long refresh current<br>(4,096 cycles/128 ms,<br>only for the $\mu\text{PD42S16165L}$ ) |                                                                                                       | I <sub>CC6</sub>   | $\overline{\text{CAS}}$ before $\overline{\text{RAS}}$ refresh :<br>$t_{\text{RC}} = 31.3 \mu\text{s}$<br>$\overline{\text{RAS}}, \overline{\text{CAS}}$ :<br>$V_{\text{CC}} - 0.2 \text{ V} \leq V_{\text{IH}} \leq V_{\text{IH (MAX.)}}$<br>$0 \text{ V} \leq V_{\text{IL}} \leq 0.2 \text{ V}$<br><br>Standby:<br>$\overline{\text{RAS}}, \overline{\text{CAS}} \geq V_{\text{CC}} - 0.2 \text{ V}$<br>Address: $V_{\text{IH}}$ or $V_{\text{IL}}$<br>$\overline{\text{WE}}, \overline{\text{OE}}: V_{\text{IH}}$<br>$I_o = 0 \text{ mA}$ | $t_{\text{RAS}} \leq 300 \text{ ns}$ |      | 400  | $\mu\text{A}$ | 1, 2       |
|                                                                                                                                                   |                                                                                                       |                    |                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              | $t_{\text{RAS}} \leq 1 \mu\text{s}$  |      | 500  | $\mu\text{A}$ | 1, 2       |
| $\overline{\text{CAS}}$ before $\overline{\text{RAS}}$<br>self refresh current<br>(only for the $\mu\text{PD42S16165L}$ )                         |                                                                                                       | I <sub>CC7</sub>   | $\overline{\text{RAS}}, \overline{\text{CAS}}$ :<br>$t_{\text{RAS}} = 5 \text{ ms}$<br>$V_{\text{CC}} - 0.2 \text{ V} \leq V_{\text{IH}} \leq V_{\text{IH (MAX.)}}$<br>$0 \text{ V} \leq V_{\text{IL}} \leq 0.2 \text{ V}$<br>$I_o = 0 \text{ mA}$                                                                                                                                                                                                                                                                                           |                                      |      | 200  | $\mu\text{A}$ | 2          |
| Input leakage current                                                                                                                             |                                                                                                       | I <sub>I (L)</sub> | $V_i = 0 \text{ to } 3.6 \text{ V}$<br>All other pins not under test = 0 V                                                                                                                                                                                                                                                                                                                                                                                                                                                                   |                                      | -5   | +5   | $\mu\text{A}$ |            |
| Output leakage current                                                                                                                            |                                                                                                       | I <sub>O (L)</sub> | $V_o = 0 \text{ to } 3.6 \text{ V}$<br>Output is disabled (Hi-Z)                                                                                                                                                                                                                                                                                                                                                                                                                                                                             |                                      | -5   | +5   | $\mu\text{A}$ |            |
| High level output voltage                                                                                                                         |                                                                                                       | V <sub>OH</sub>    | $I_o = -2.0 \text{ mA}$                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                      |                                      | 2.4  |      | V             |            |
| Low level output voltage                                                                                                                          |                                                                                                       | V <sub>OL</sub>    | $I_o = +2.0 \text{ mA}$                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                      |                                      |      | 0.4  | V             |            |

- Notes**
1. I<sub>CC1</sub>, I<sub>CC3</sub>, I<sub>CC4</sub>, I<sub>CC5</sub> and I<sub>CC6</sub> depend on cycle rates ( $t_{\text{RC}}$  and  $t_{\text{HPC}}$ ).
  2. Specified values are obtained with outputs unloaded.
  3. I<sub>CC1</sub> and I<sub>CC3</sub> are measured assuming that address can be changed once or less during  $\overline{\text{RAS}} \leq V_{\text{IL (MAX.)}}$  and  $\overline{\text{CAS}} \geq V_{\text{IH (MIN.)}}$ .
  4. I<sub>CC3</sub> is measured assuming that all column address inputs are held at either high or low.
  5. I<sub>CC4</sub> is measured assuming that all column address inputs are switched only once during each hyper page (EDO) cycle.

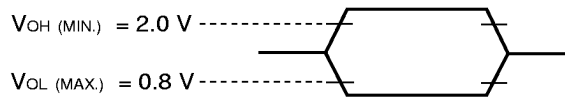
## ★ AC Characteristics (Recommended Operating Conditions unless otherwise noted)

## AC Characteristics Test Conditions

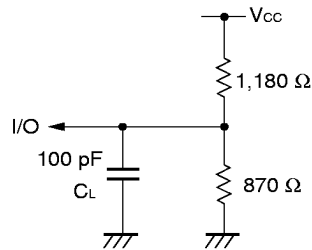
(1) Input timing specification



(2) Output timing specification



(3) Output load condition



## Common to Read, Write, Read Modify Write Cycle

| Parameter                                                              |                         | Symbol           | t <sub>RAC</sub> = 50 ns |        | t <sub>RAC</sub> = 60 ns |        | t <sub>RAC</sub> = 70 ns |        | Unit | Notes |
|------------------------------------------------------------------------|-------------------------|------------------|--------------------------|--------|--------------------------|--------|--------------------------|--------|------|-------|
|                                                                        |                         |                  | MIN.                     | MAX.   | MIN.                     | MAX.   | MIN.                     | MAX.   |      |       |
| Read / Write cycle time                                                |                         | t <sub>RC</sub>  | 84                       | —      | 104                      | —      | 124                      | —      | ns   |       |
| $\overline{\text{RAS}}$ precharge time                                 |                         | t <sub>RP</sub>  | 30                       | —      | 40                       | —      | 50                       | —      | ns   |       |
| $\overline{\text{CAS}}$ precharge time                                 |                         | t <sub>CPN</sub> | 8                        | —      | 10                       | —      | 10                       | —      | ns   |       |
| $\overline{\text{RAS}}$ pulse width                                    |                         | t <sub>RAS</sub> | 50                       | 10,000 | 60                       | 10,000 | 70                       | 10,000 | ns   | 1     |
| $\overline{\text{CAS}}$ pulse width                                    |                         | t <sub>CAS</sub> | 8                        | 10,000 | 10                       | 10,000 | 12                       | 10,000 | ns   |       |
| $\overline{\text{RAS}}$ hold time                                      |                         | t <sub>RSH</sub> | 10                       | —      | 10                       | —      | 12                       | —      | ns   |       |
| $\overline{\text{CAS}}$ hold time                                      |                         | t <sub>CSH</sub> | 38                       | —      | 40                       | —      | 50                       | —      | ns   |       |
| $\overline{\text{RAS}}$ to $\overline{\text{CAS}}$ delay time          |                         | t <sub>RCD</sub> | 11                       | 37     | 14                       | 45     | 14                       | 52     | ns   | 2     |
| $\overline{\text{RAS}}$ to column address delay time                   |                         | t <sub>RAD</sub> | 9                        | 25     | 12                       | 30     | 12                       | 35     | ns   | 2     |
| $\overline{\text{CAS}}$ to $\overline{\text{RAS}}$ precharge time      |                         | t <sub>CRP</sub> | 5                        | —      | 5                        | —      | 5                        | —      | ns   | 3     |
| Row address setup time                                                 |                         | t <sub>ASR</sub> | 0                        | —      | 0                        | —      | 0                        | —      | ns   |       |
| Row address hold time                                                  |                         | t <sub>RAH</sub> | 7                        | —      | 10                       | —      | 10                       | —      | ns   |       |
| Column address setup time                                              |                         | t <sub>ASC</sub> | 0                        | —      | 0                        | —      | 0                        | —      | ns   |       |
| Column address hold time                                               |                         | t <sub>CAH</sub> | 7                        | —      | 10                       | —      | 12                       | —      | ns   |       |
| $\overline{\text{OE}}$ lead time referenced to $\overline{\text{RAS}}$ |                         | t <sub>OES</sub> | 0                        | —      | 0                        | —      | 0                        | —      | ns   |       |
| $\overline{\text{CAS}}$ to data setup time                             |                         | t <sub>CLZ</sub> | 0                        | —      | 0                        | —      | 0                        | —      | ns   |       |
| $\overline{\text{OE}}$ to data setup time                              |                         | t <sub>OLZ</sub> | 0                        | —      | 0                        | —      | 0                        | —      | ns   |       |
| $\overline{\text{OE}}$ to data delay time                              |                         | t <sub>OED</sub> | 10                       | —      | 13                       | —      | 15                       | —      | ns   |       |
| Masked byte write hold time referenced to $\overline{\text{RAS}}$      |                         | t <sub>MRH</sub> | 0                        | —      | 0                        | —      | 0                        | —      | ns   |       |
| Transition time (rise and fall)                                        |                         | t <sub>T</sub>   | 1                        | 50     | 1                        | 50     | 1                        | 50     | ns   |       |
| Refresh time                                                           | $\mu\text{PD42S16165L}$ | t <sub>REF</sub> | —                        | 128    | —                        | 128    | —                        | 128    | ms   | 4     |
|                                                                        | $\mu\text{PD4216165L}$  |                  | —                        | 64     | —                        | 64     | —                        | 64     | ms   |       |

- Notes** 1. In  $\overline{\text{CAS}}$  before  $\overline{\text{RAS}}$  refresh cycles,  $t_{\text{RAS}}(\text{MAX.})$  is 100  $\mu\text{s}$ .  
 If 10  $\mu\text{s}$  <  $t_{\text{RAS}}$  < 100  $\mu\text{s}$ ,  $\overline{\text{RAS}}$  precharge time for  $\overline{\text{CAS}}$  before  $\overline{\text{RAS}}$  self refresh ( $t_{\text{RPS}}$ ) is applied.
2. For read cycles, access time is defined as follows:

| Input conditions                                                                                        | Access time                   | Access time from $\overline{\text{RAS}}$       |
|---------------------------------------------------------------------------------------------------------|-------------------------------|------------------------------------------------|
| $t_{\text{RAD}} \leq t_{\text{RAD}}(\text{MAX.})$ and $t_{\text{RCD}} \leq t_{\text{RCD}}(\text{MAX.})$ | $t_{\text{RAC}}(\text{MAX.})$ | $t_{\text{RAC}}(\text{MAX.})$                  |
| $t_{\text{RAD}} > t_{\text{RAD}}(\text{MAX.})$ and $t_{\text{RCD}} \leq t_{\text{RCD}}(\text{MAX.})$    | $t_{\text{AA}}(\text{MAX.})$  | $t_{\text{RAD}} + t_{\text{AA}}(\text{MAX.})$  |
| $t_{\text{RCD}} > t_{\text{RCD}}(\text{MAX.})$                                                          | $t_{\text{CAC}}(\text{MAX.})$ | $t_{\text{RCD}} + t_{\text{CAC}}(\text{MAX.})$ |

$t_{\text{RAD}}(\text{MAX.})$  and  $t_{\text{RCD}}(\text{MAX.})$  are specified as reference points only; they are not restrictive operating parameters. They are used to determine which access time ( $t_{\text{RAC}}$ ,  $t_{\text{AA}}$  or  $t_{\text{CAC}}$ ) is to be used for finding out when output data will be available. Therefore, the input conditions  $t_{\text{RAD}} \geq t_{\text{RAD}}(\text{MAX.})$  and  $t_{\text{RCD}} \geq t_{\text{RCD}}(\text{MAX.})$  will not cause any operation problems.

3.  $t_{\text{CRP}}(\text{MIN.})$  requirement is applied to  $\overline{\text{RAS}}$ ,  $\overline{\text{CAS}}$  cycles.
4. This specification is applied only to the  $\mu$ PD42S16165L.

### Read Cycle

| Parameter                                                      | Symbol           | $t_{\text{RAC}} = 50 \text{ ns}$ |      | $t_{\text{RAC}} = 60 \text{ ns}$ |      | $t_{\text{RAC}} = 70 \text{ ns}$ |      | Unit | Notes |
|----------------------------------------------------------------|------------------|----------------------------------|------|----------------------------------|------|----------------------------------|------|------|-------|
|                                                                |                  | MIN.                             | MAX. | MIN.                             | MAX. | MIN.                             | MAX. |      |       |
| Access time from $\overline{\text{RAS}}$                       | $t_{\text{RAC}}$ | —                                | 50   | —                                | 60   | —                                | 70   | ns   | 1     |
| Access time from $\overline{\text{CAS}}$                       | $t_{\text{CAC}}$ | —                                | 15   | —                                | 17   | —                                | 18   | ns   | 1     |
| Access time from column address                                | $t_{\text{AA}}$  | —                                | 25   | —                                | 30   | —                                | 35   | ns   | 1     |
| Access time from $\overline{\text{OE}}$                        | $t_{\text{OEA}}$ | —                                | 13   | —                                | 15   | —                                | 18   | ns   |       |
| Column address lead time referenced to $\overline{\text{RAS}}$ | $t_{\text{RAL}}$ | 25                               | —    | 30                               | —    | 35                               | —    | ns   |       |
| Read command setup time                                        | $t_{\text{RCS}}$ | 0                                | —    | 0                                | —    | 0                                | —    | ns   |       |
| Read command hold time referenced to $\overline{\text{RAS}}$   | $t_{\text{RRH}}$ | 0                                | —    | 0                                | —    | 0                                | —    | ns   | 2     |
| Read command hold time referenced to $\overline{\text{CAS}}$   | $t_{\text{RCH}}$ | 0                                | —    | 0                                | —    | 0                                | —    | ns   | 2     |
| Output buffer turn-off delay time from $\overline{\text{OE}}$  | $t_{\text{OEZ}}$ | 0                                | 10   | 0                                | 13   | 0                                | 15   | ns   | 3     |
| $\overline{\text{CAS}}$ hold time to $\overline{\text{OE}}$    | $t_{\text{CHO}}$ | 5                                | —    | 5                                | —    | 5                                | —    | ns   | 4     |

- Notes** 1. For read cycles, access time is defined as follows:

| Input conditions                                                                                        | Access time                   | Access time from $\overline{\text{RAS}}$       |
|---------------------------------------------------------------------------------------------------------|-------------------------------|------------------------------------------------|
| $t_{\text{RAD}} \leq t_{\text{RAD}}(\text{MAX.})$ and $t_{\text{RCD}} \leq t_{\text{RCD}}(\text{MAX.})$ | $t_{\text{RAC}}(\text{MAX.})$ | $t_{\text{RAC}}(\text{MAX.})$                  |
| $t_{\text{RAD}} > t_{\text{RAD}}(\text{MAX.})$ and $t_{\text{RCD}} \leq t_{\text{RCD}}(\text{MAX.})$    | $t_{\text{AA}}(\text{MAX.})$  | $t_{\text{RAD}} + t_{\text{AA}}(\text{MAX.})$  |
| $t_{\text{RCD}} > t_{\text{RCD}}(\text{MAX.})$                                                          | $t_{\text{CAC}}(\text{MAX.})$ | $t_{\text{RCD}} + t_{\text{CAC}}(\text{MAX.})$ |

$t_{\text{RAD}}(\text{MAX.})$  and  $t_{\text{RCD}}(\text{MAX.})$  are specified as reference points only; they are not restrictive operating parameters. They are used to determine which access time ( $t_{\text{RAC}}$ ,  $t_{\text{AA}}$  or  $t_{\text{CAC}}$ ) is to be used for finding out when output data will be available. Therefore, the input conditions  $t_{\text{RAD}} \geq t_{\text{RAD}}(\text{MAX.})$  and  $t_{\text{RCD}} \geq t_{\text{RCD}}(\text{MAX.})$  will not cause any operation problems.

2. Either  $t_{\text{RCH}}(\text{MIN.})$  or  $t_{\text{RRH}}(\text{MIN.})$  should be met in read cycles.
3.  $t_{\text{OEZ}}(\text{MAX.})$  defines the time when the output achieves the condition of Hi-Z and is not referenced to  $V_{\text{OH}}$  or  $V_{\text{OL}}$ .
4.  $\overline{\text{WE}}$ : inactive (in read cycle)  
 $\overline{\text{CAS}}$ : inactive,  $\overline{\text{OE}}$ : active .....  $t_{\text{CHO}}$  is effective.  
 $\overline{\text{CAS}}$ ,  $\overline{\text{OE}}$ : active .....  $t_{\text{OCH}}$  is effective.

**Write Cycle**

| Parameter                                                | Symbol           | t <sub>RAC</sub> = 50 ns |      | t <sub>RAC</sub> = 60 ns |      | t <sub>RAC</sub> = 70 ns |      | Unit | Notes |
|----------------------------------------------------------|------------------|--------------------------|------|--------------------------|------|--------------------------|------|------|-------|
|                                                          |                  | MIN.                     | MAX. | MIN.                     | MAX. | MIN.                     | MAX. |      |       |
| $\overline{WE}$ hold time referenced to $\overline{CAS}$ | t <sub>WCH</sub> | 7                        | –    | 10                       | –    | 10                       | –    | ns   | 1     |
| $\overline{WE}$ pulse width                              | t <sub>WP</sub>  | 8                        | –    | 10                       | –    | 10                       | –    | ns   | 1     |
| $\overline{WE}$ lead time referenced to $\overline{RAS}$ | t <sub>RWL</sub> | 10                       | –    | 10                       | –    | 12                       | –    | ns   |       |
| $\overline{WE}$ lead time referenced to $\overline{CAS}$ | t <sub>CWL</sub> | 8                        | –    | 10                       | –    | 12                       | –    | ns   |       |
| $\overline{WE}$ setup time                               | t <sub>WCS</sub> | 0                        | –    | 0                        | –    | 0                        | –    | ns   | 2     |
| $\overline{OE}$ hold time                                | t <sub>OEH</sub> | 0                        | –    | 0                        | –    | 0                        | –    | ns   |       |
| Data-in setup time                                       | t <sub>DS</sub>  | 0                        | –    | 0                        | –    | 0                        | –    | ns   | 3     |
| Data-in hold time                                        | t <sub>DH</sub>  | 7                        | –    | 10                       | –    | 10                       | –    | ns   | 3     |

- Notes**
1. t<sub>WP</sub> (MIN.) is applied to late write cycles or read modify write cycles. In early write cycles, t<sub>WCH</sub> (MIN.) should be met.
  2. If t<sub>WCS</sub> ≥ t<sub>WCS</sub> (MIN.), the cycle is an early write cycle and the data out will remain Hi-Z through the entire cycle.
  3. t<sub>DS</sub> (MIN.) and t<sub>DH</sub> (MIN.) are referenced to the  $\overline{CAS}$  falling edge in early write cycles. In late write cycles and read modify write cycles, they are referenced to the  $\overline{WE}$  falling edge.

**Read Modify Write Cycle**

| Parameter                                      | Symbol           | t <sub>RAC</sub> = 50 ns |      | t <sub>RAC</sub> = 60 ns |      | t <sub>RAC</sub> = 70 ns |      | Unit | Notes |
|------------------------------------------------|------------------|--------------------------|------|--------------------------|------|--------------------------|------|------|-------|
|                                                |                  | MIN.                     | MAX. | MIN.                     | MAX. | MIN.                     | MAX. |      |       |
| Read modify write cycle time                   | t <sub>RWC</sub> | 107                      | –    | 133                      | –    | 157                      | –    | ns   |       |
| $\overline{RAS}$ to $\overline{WE}$ delay time | t <sub>RWD</sub> | 64                       | –    | 77                       | –    | 89                       | –    | ns   | 1     |
| $\overline{CAS}$ to $\overline{WE}$ delay time | t <sub>CWD</sub> | 27                       | –    | 32                       | –    | 37                       | –    | ns   | 1     |
| Column address to $\overline{WE}$ delay time   | t <sub>AWD</sub> | 39                       | –    | 47                       | –    | 54                       | –    | ns   | 1     |

- Note**
1. If t<sub>WCS</sub> ≥ t<sub>WCS</sub> (MIN.), the cycle is an early write cycle and the data out will remain Hi-Z through the entire cycle. If t<sub>RWD</sub> ≥ t<sub>RWD</sub> (MIN.), t<sub>CWD</sub> ≥ t<sub>CWD</sub> (MIN.), t<sub>AWD</sub> ≥ t<sub>AWD</sub> (MIN.) and t<sub>CPWD</sub> ≥ t<sub>CPWD</sub> (MIN.), the cycle is a read modify write cycle and the data out will contain data read from the selected cell. If neither of the above conditions is met, the state of the data out is indeterminate.

## Hyper Page Mode (EDO)

| Parameter                                                                | Symbol      | $t_{RAC} = 50 \text{ ns}$ |         | $t_{RAC} = 60 \text{ ns}$ |         | $t_{RAC} = 70 \text{ ns}$ |         | Unit | Notes |
|--------------------------------------------------------------------------|-------------|---------------------------|---------|---------------------------|---------|---------------------------|---------|------|-------|
|                                                                          |             | MIN.                      | MAX.    | MIN.                      | MAX.    | MIN.                      | MAX.    |      |       |
| Read / Write cycle time                                                  | $t_{HPC}$   | 20                        | —       | 25                        | —       | 30                        | —       | ns   | 1     |
| $\overline{\text{RAS}}$ pulse width                                      | $t_{RASP}$  | 50                        | 125,000 | 60                        | 125,000 | 70                        | 125,000 | ns   |       |
| $\overline{\text{CAS}}$ pulse width                                      | $t_{HCAS}$  | 8                         | 10,000  | 10                        | 10,000  | 12                        | 10,000  | ns   |       |
| $\overline{\text{CAS}}$ precharge time                                   | $t_{CP}$    | 8                         | —       | 10                        | —       | 10                        | —       | ns   |       |
| Access time from $\overline{\text{CAS}}$ precharge                       | $t_{ACP}$   | —                         | 30      | —                         | 35      | —                         | 40      | ns   |       |
| $\overline{\text{CAS}}$ precharge to $\overline{\text{WE}}$ delay time   | $t_{CPWD}$  | 41                        | —       | 52                        | —       | 59                        | —       | ns   | 2     |
| $\overline{\text{RAS}}$ hold time from $\overline{\text{CAS}}$ precharge | $t_{RHCP}$  | 30                        | —       | 35                        | —       | 40                        | —       | ns   |       |
| Read modify write cycle time                                             | $t_{HPRWC}$ | 52                        | —       | 66                        | —       | 75                        | —       | ns   |       |
| Data output hold time                                                    | $t_{DHC}$   | 5                         | —       | 5                         | —       | 5                         | —       | ns   |       |
| $\overline{\text{OE}}$ to $\overline{\text{CAS}}$ hold time              | $t_{OCH}$   | 5                         | —       | 5                         | —       | 5                         | —       | ns   | 3     |
| $\overline{\text{OE}}$ precharge time                                    | $t_{OEP}$   | 5                         | —       | 5                         | —       | 5                         | —       | ns   |       |
| Output buffer turn-off delay from $\overline{\text{WE}}$                 | $t_{WEZ}$   | 0                         | 10      | 0                         | 13      | 0                         | 15      | ns   | 4,5   |
| $\overline{\text{WE}}$ pulse width                                       | $t_{WPZ}$   | 7                         | —       | 10                        | —       | 10                        | —       | ns   | 5     |
| Output buffer turn-off delay from $\overline{\text{RAS}}$                | $t_{OFR}$   | 0                         | 10      | 0                         | 13      | 0                         | 15      | ns   | 4,5   |
| Output buffer turn-off delay from $\overline{\text{CAS}}$                | $t_{OFC}$   | 0                         | 10      | 0                         | 13      | 0                         | 15      | ns   | 4,5   |

**Notes 1.**  $t_{HPC}$  (MIN.) is applied to  $\overline{\text{CAS}}$  access.

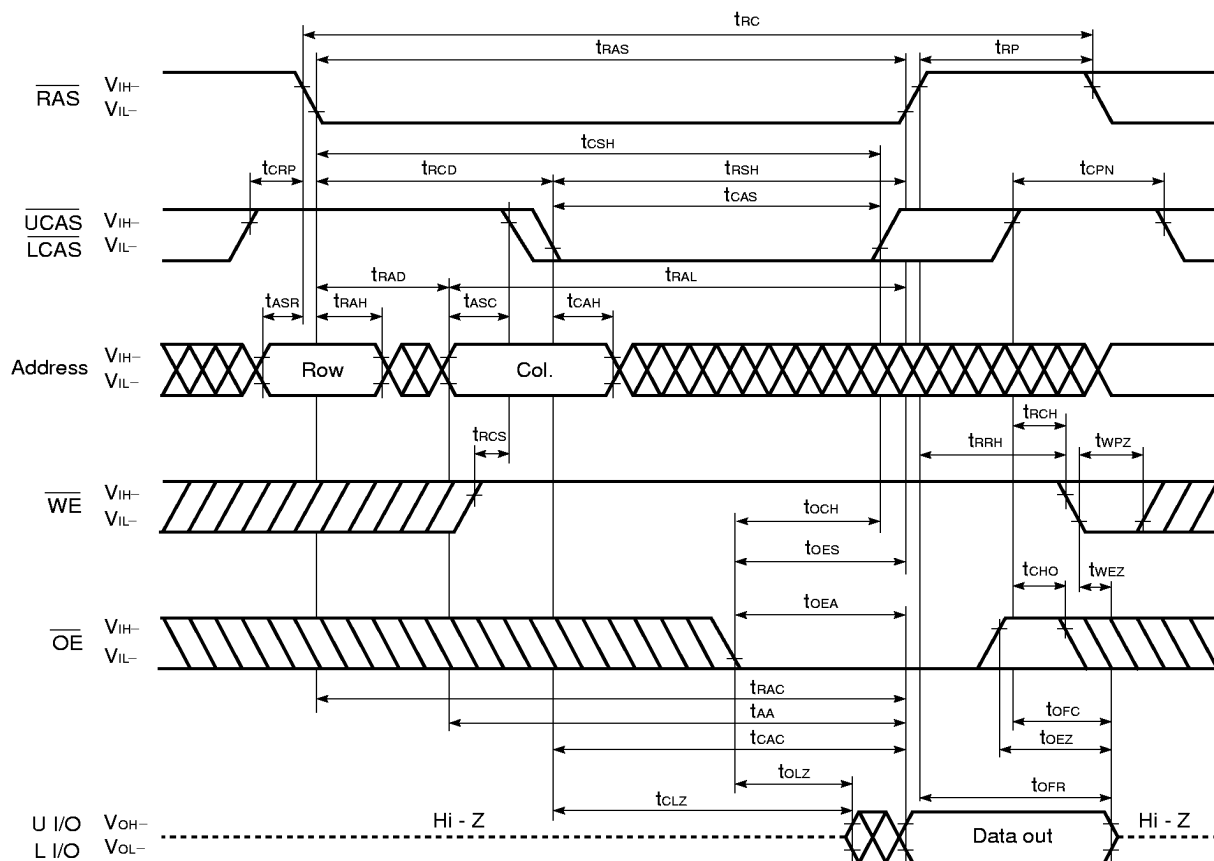
2. If  $t_{WCS} \geq t_{WCS}(\text{MIN.})$ , the cycle is an early write cycle and the data out will remain Hi-Z through the entire cycle. If  $t_{RWd} \geq t_{RWd}(\text{MIN.})$ ,  $t_{CWD} \geq t_{CWD}(\text{MIN.})$ ,  $t_{AWD} \geq t_{AWD}(\text{MIN.})$  and  $t_{CPWD} \geq t_{CPWD}(\text{MIN.})$ , the cycle is a read modify write cycle and the data out will contain data read from the selected cell. If neither of the above conditions is met, the state of the data out is indeterminate.
  3.  $\overline{\text{WE}}$ : inactive (in read cycle)  
 $\overline{\text{CAS}}$ : inactive,  $\overline{\text{OE}}$ : active .....  $t_{CHO}$  is effective.  
 $\overline{\text{CAS}}$ ,  $\overline{\text{OE}}$ : active .....  $t_{OCH}$  is effective.
  4.  $t_{OFC}(\text{MAX.})$ ,  $t_{OFR}(\text{MAX.})$  and  $t_{WEZ}(\text{MAX.})$  define the time when the output achieves the conditions of Hi-Z and is not referenced to  $V_{OH}$  or  $V_{OL}$ .
  5. To make I/Os to Hi-Z in read cycle, it is necessary to control  $\overline{\text{RAS}}$ ,  $\overline{\text{CAS}}$ ,  $\overline{\text{WE}}$ ,  $\overline{\text{OE}}$  as follows. The effective specification depends on state of each signal.
    - (1) Both  $\overline{\text{RAS}}$  and  $\overline{\text{CAS}}$  are inactive (at the end of the read cycle)  
 $\overline{\text{WE}}$ : inactive,  $\overline{\text{OE}}$ : active  
 $t_{OFC}$  is effective when  $\overline{\text{RAS}}$  is inactivated before  $\overline{\text{CAS}}$  is inactivated.  
 $t_{OFR}$  is effective when  $\overline{\text{CAS}}$  is inactivated before  $\overline{\text{RAS}}$  is inactivated.  
 The slower of  $t_{OFC}$  and  $t_{OFR}$  becomes effective.
    - (2) Both  $\overline{\text{RAS}}$  and  $\overline{\text{CAS}}$  are active or either  $\overline{\text{RAS}}$  or  $\overline{\text{CAS}}$  is active (in read cycle)  
 $\overline{\text{WE}}$ ,  $\overline{\text{OE}}$ : inactive .....  $t_{OEZ}$  is effective.  
 Both  $\overline{\text{RAS}}$  and  $\overline{\text{CAS}}$  are inactive or  $\overline{\text{RAS}}$  is active and  $\overline{\text{CAS}}$  is inactive (at the end of read cycle)  
 $\overline{\text{WE}}$ ,  $\overline{\text{OE}}$ : active and either  $t_{RRH}$  or  $t_{RCH}$  must be met .....  $t_{WEZ}$  and  $t_{WPZ}$  are effective.  
 The faster of  $t_{OEZ}$  and  $t_{WEZ}$  becomes effective.
- The faster of (1) and (2) becomes effective.

## Refresh Cycle

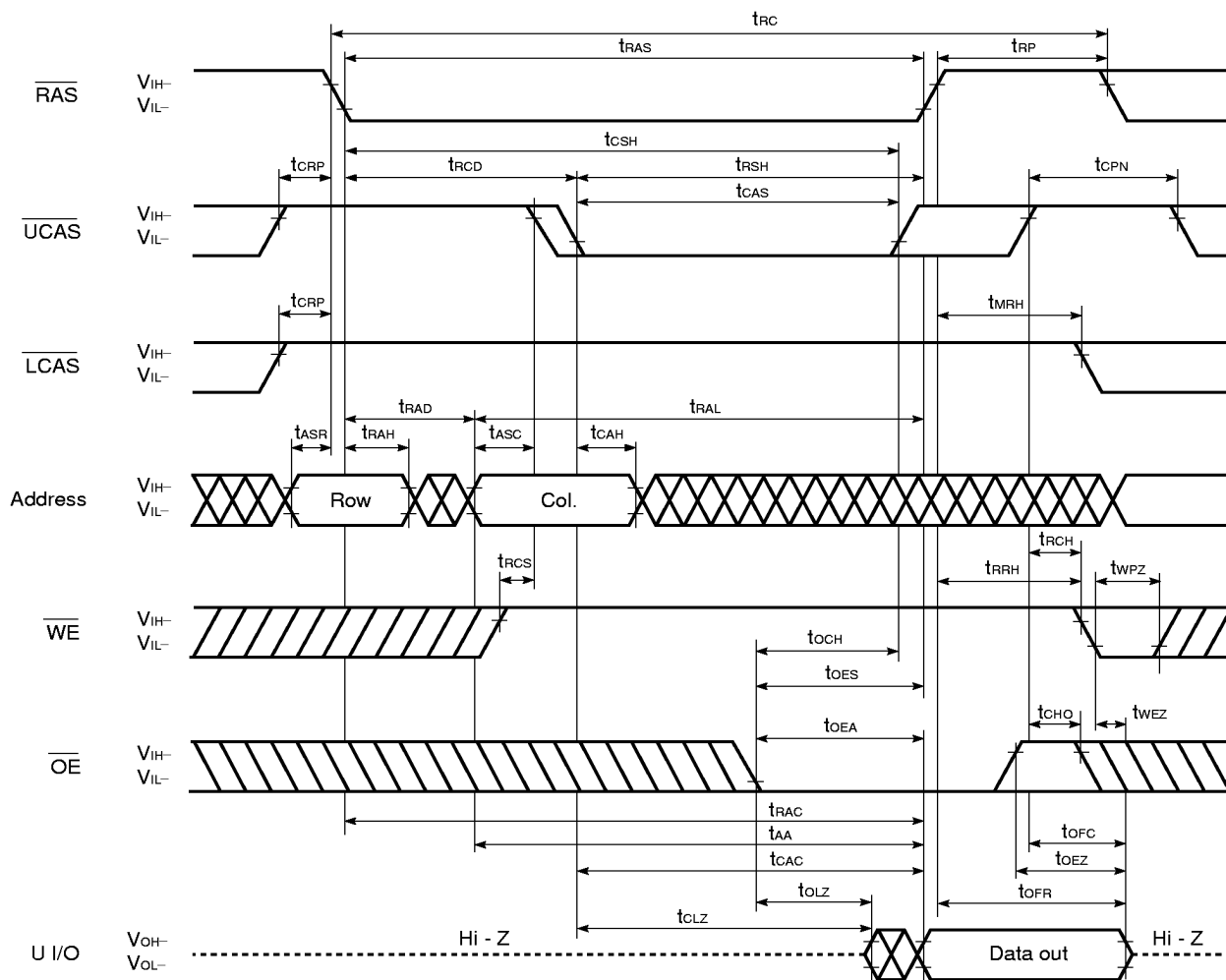
| Parameter                                                                                | Symbol     | $t_{RAC} = 50 \text{ ns}$ |      | $t_{RAC} = 60 \text{ ns}$ |      | $t_{RAC} = 70 \text{ ns}$ |      | Unit    | Notes |
|------------------------------------------------------------------------------------------|------------|---------------------------|------|---------------------------|------|---------------------------|------|---------|-------|
|                                                                                          |            | MIN.                      | MAX. | MIN.                      | MAX. | MIN.                      | MAX. |         |       |
| $\overline{CAS}$ setup time                                                              | $t_{CSR}$  | 5                         | —    | 5                         | —    | 5                         | —    | ns      |       |
| $\overline{CAS}$ hold time ( $\overline{CAS}$ before $\overline{RAS}$ refresh)           | $t_{CHR}$  | 10                        | —    | 10                        | —    | 10                        | —    | ns      |       |
| $\overline{RAS}$ precharge $\overline{CAS}$ hold time                                    | $t_{RPC}$  | 5                         | —    | 5                         | —    | 5                         | —    | ns      |       |
| $\overline{RAS}$ pulse width ( $\overline{CAS}$ before $\overline{RAS}$ self refresh)    | $t_{RASS}$ | 100                       | —    | 100                       | —    | 100                       | —    | $\mu s$ | 1     |
| $\overline{RAS}$ precharge time ( $\overline{CAS}$ before $\overline{RAS}$ self refresh) | $t_{RPS}$  | 90                        | —    | 110                       | —    | 130                       | —    | ns      | 1     |
| $\overline{CAS}$ hold time ( $\overline{CAS}$ before $\overline{RAS}$ self refresh)      | $t_{CHS}$  | −50                       | —    | −50                       | —    | −50                       | —    | ns      | 1     |
| $\overline{WE}$ hold time                                                                | $t_{WHR}$  | 15                        | —    | 15                        | —    | 15                        | —    | ns      |       |

**Note 1.** This specification is applied only to the  $\mu$ PD42S16165L.

Read Cycle

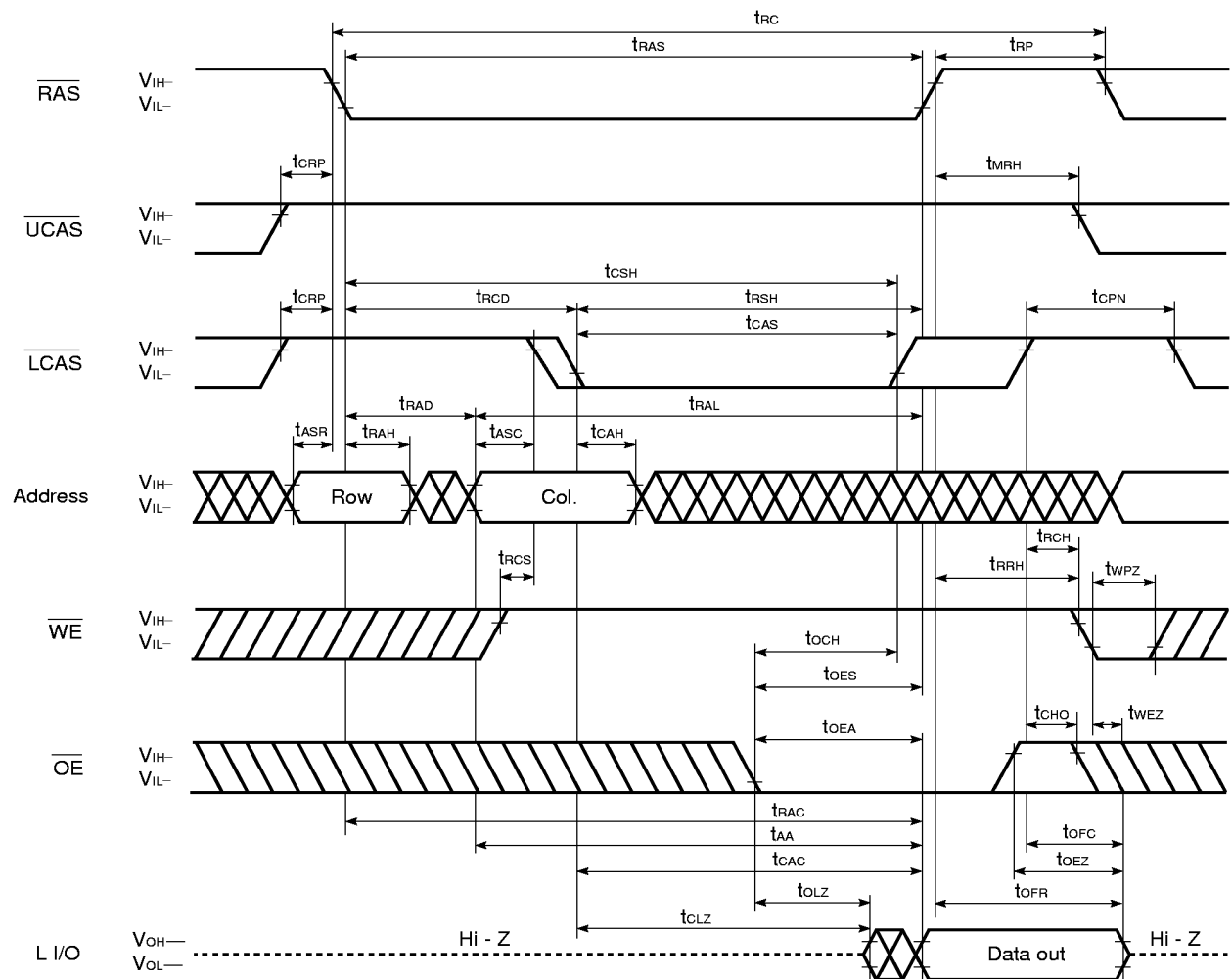


Upper Byte Read Cycle



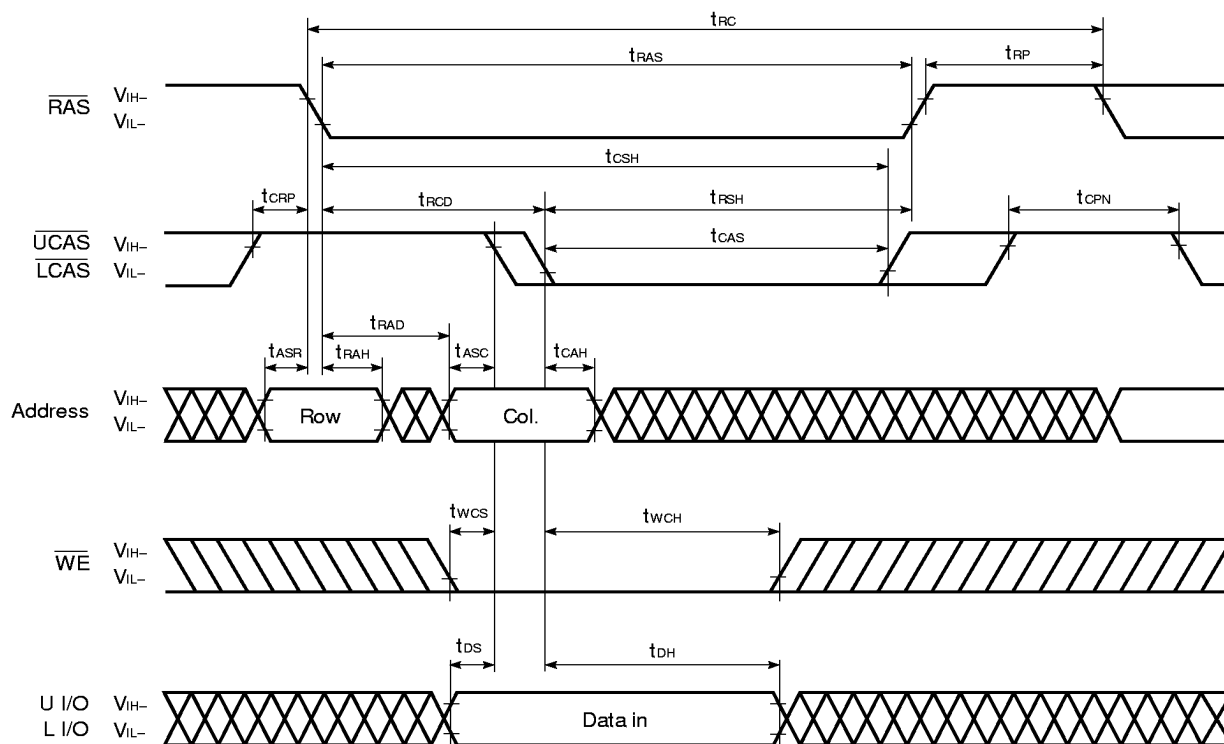
Remark L I/O: Hi-Z

Lower Byte Read Cycle



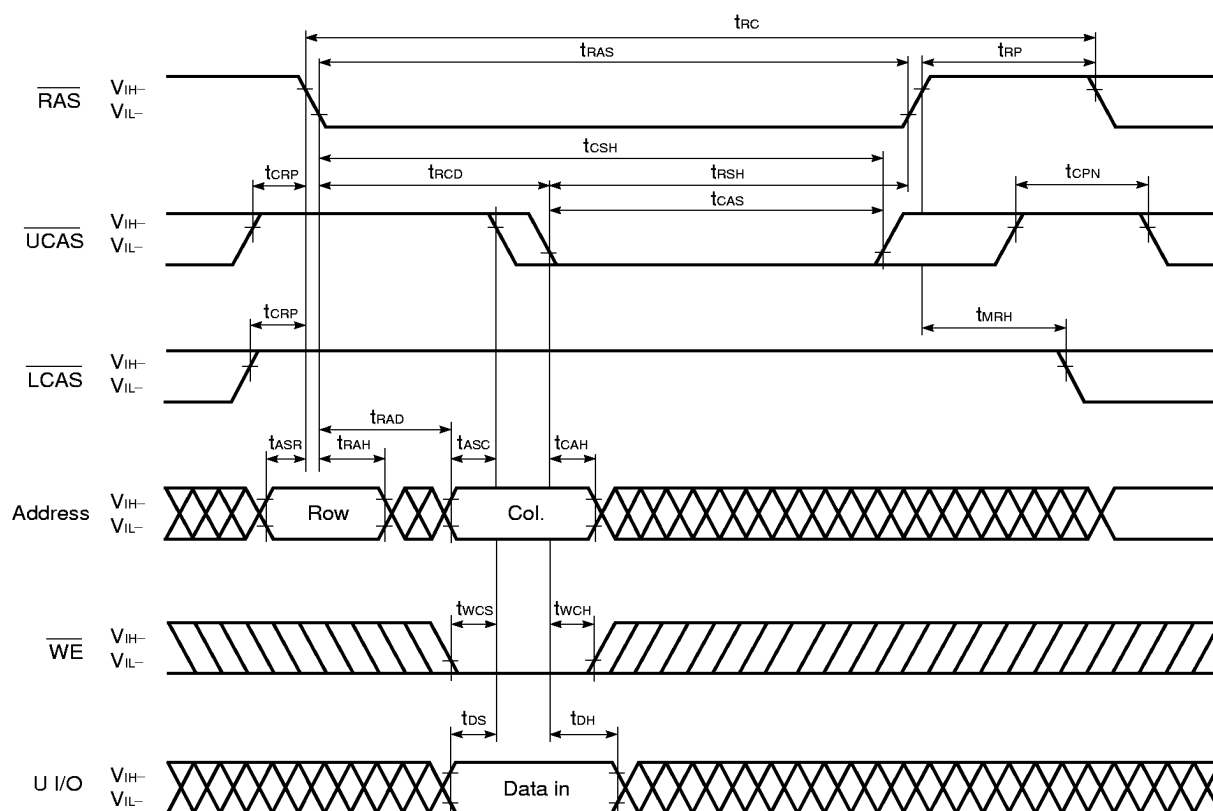
Remark U I/O: Hi-Z

## Early Write Cycle



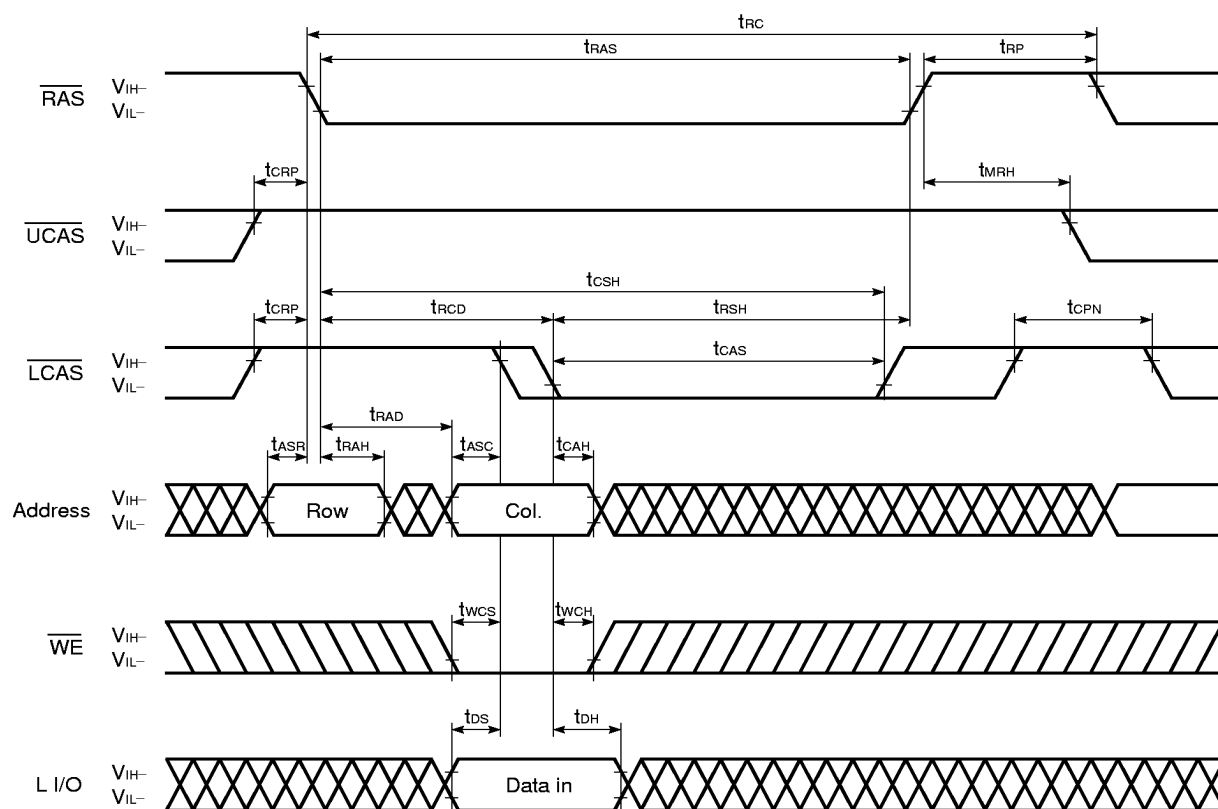
**Remark**  $\overline{\text{OE}}$ : Don't care

Upper Byte Early Write Cycle



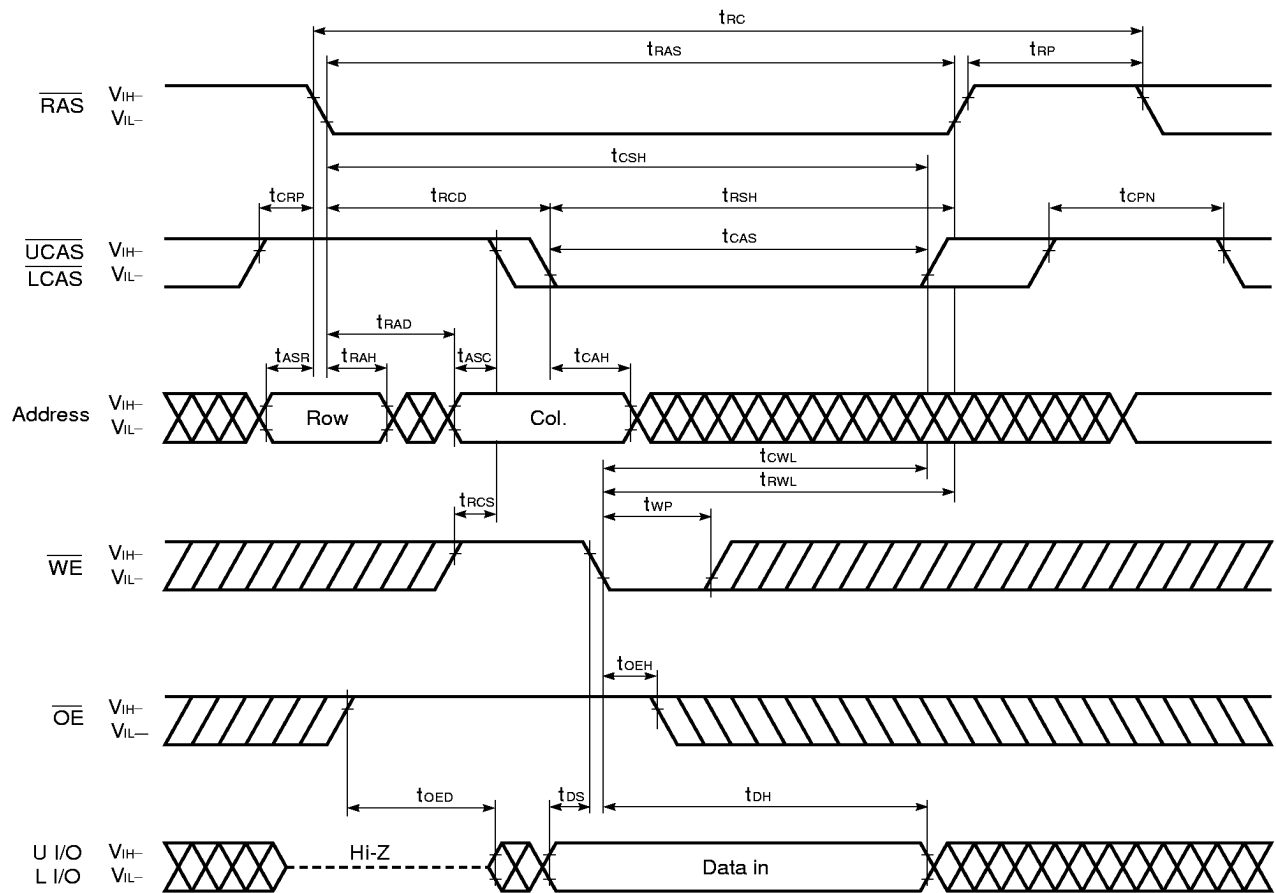
**Remark**  $\overline{\text{OE}}$ , L I/O: Don't care

## Lower Byte Early Write Cycle

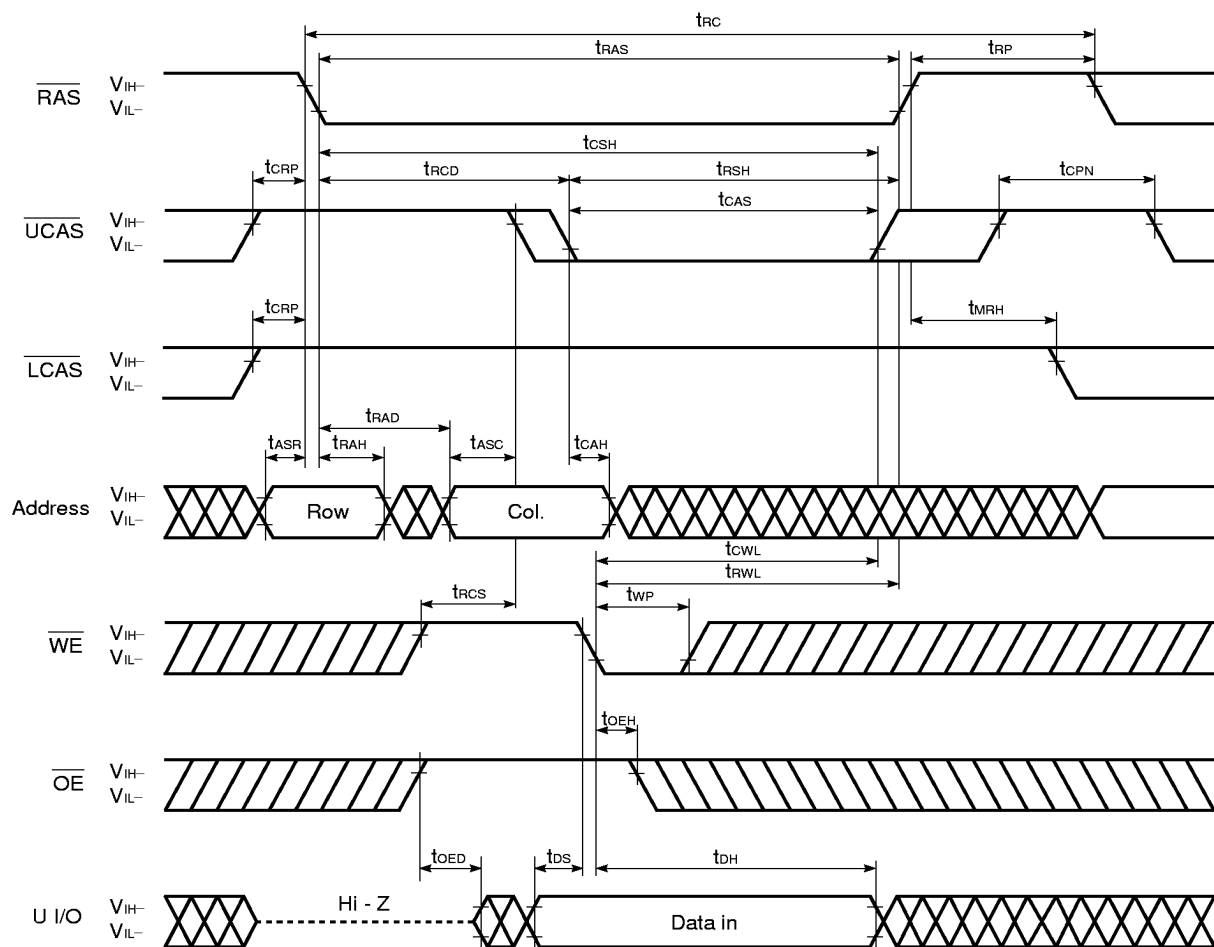


**Remark**  $\overline{\text{OE}}$ , U I/O: Don't care

Late Write Cycle

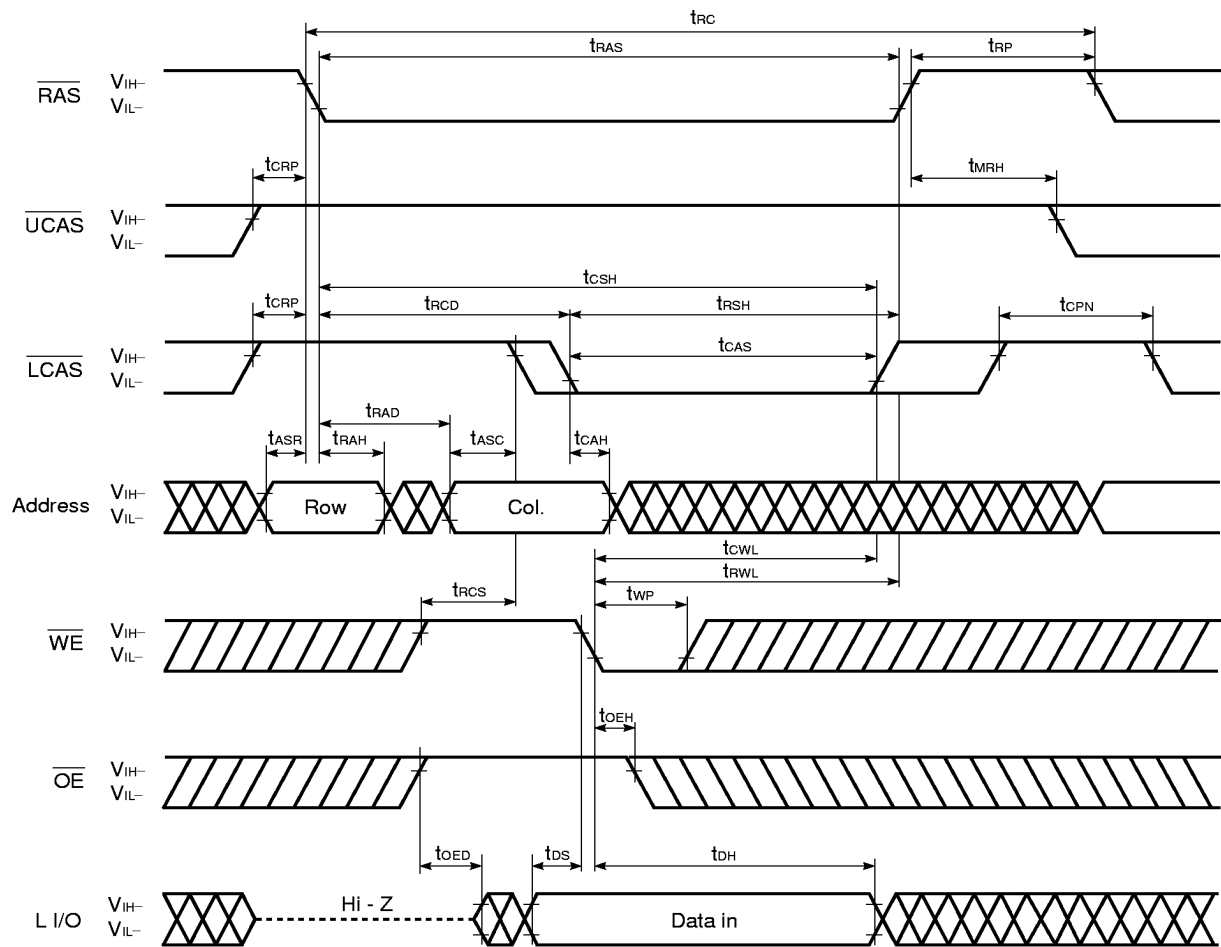


# Upper Byte Late Write Cycle



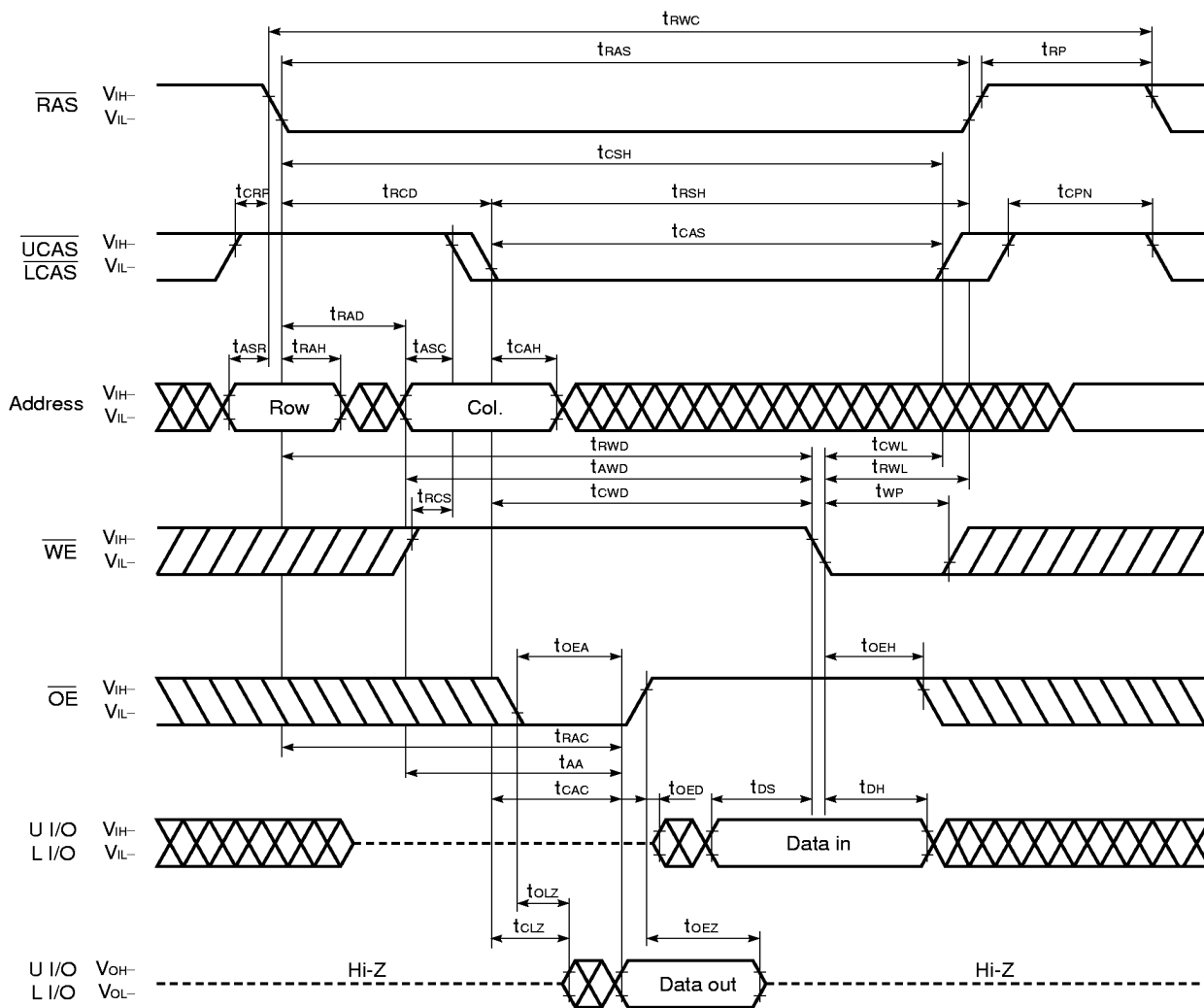
**Remark** L I/O: Don't care

Lower Byte Late Write Cycle



**Remark** U I/O: Don't care

## Read Modify Write Cycle



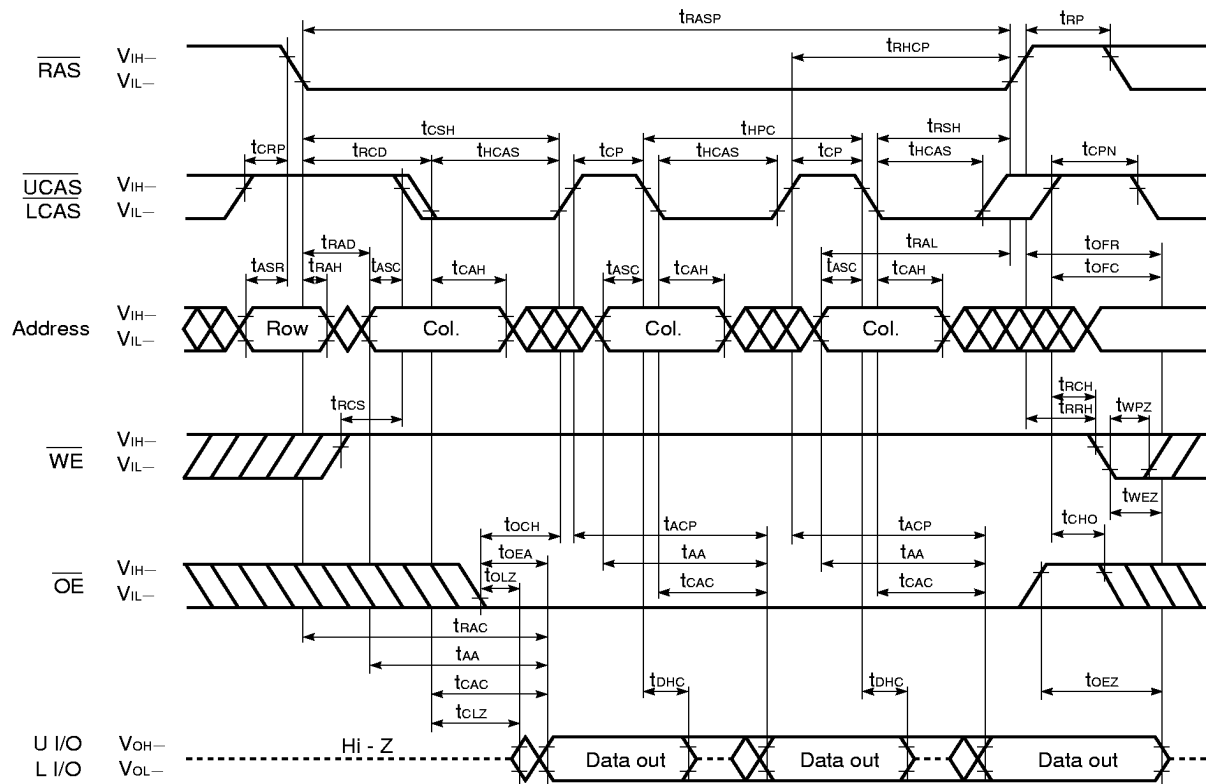
The timing diagram illustrates the relationship between various control and data signals for the 64K1602 LCD module. The signals and their timing parameters are as follows:

- RAS:** Row Address Strobe. Timing parameters include  $t_{RAS}$  (high pulse width),  $t_{RWC}$  (high-to-low transition),  $t_{RP}$  (low-to-high transition),  $t_{CRP}$  (setup before RAS),  $t_{RCD}$  (hold after RAS),  $t_{CSH}$  (hold after UCAS),  $t_{RSH}$  (hold after LCAS), and  $t_{CPN}$  (setup before UCAS).
- UCAS:** User Command Address Strobe. Timing parameters include  $t_{UCAS}$  (high pulse width),  $t_{CRP}$  (setup before UCAS),  $t_{RCD}$  (hold after RAS),  $t_{CSH}$  (hold after UCAS),  $t_{RSH}$  (hold after LCAS),  $t_{CAS}$  (high-to-low transition), and  $t_{CPN}$  (setup before UCAS).
- LCAS:** Load Command Address Strobe. Timing parameters include  $t_{LCAS}$  (high pulse width),  $t_{CRP}$  (setup before LCAS),  $t_{RCD}$  (hold after RAS),  $t_{CSH}$  (hold after UCAS),  $t_{RSH}$  (hold after LCAS),  $t_{CAS}$  (high-to-low transition),  $t_{MRH}$  (hold after LCAS), and  $t_{CPN}$  (setup before UCAS).
- Address:** Data bus for Row and Column addresses. Timing parameters include  $t_{ASR}$  (setup before RAS),  $t_{RAH}$  (hold after RAS),  $t_{ASC}$  (setup before UCAS),  $t_{CAH}$  (hold after UCAS),  $t_{RAD}$  (high-to-low transition),  $t_{AWD}$  (high-to-low transition),  $t_{CWD}$  (high-to-low transition),  $t_{RCS}$  (hold after RAS),  $t_{CWL}$  (high-to-low transition),  $t_{RWL}$  (high-to-low transition), and  $t_{WP}$  (high-to-low transition).
- WE:** Write Enable. Timing parameters include  $t_{WE}$  (high pulse width),  $t_{OE}$  (high-to-low transition),  $t_{OE}$  (high-to-low transition), and  $t_{OE}$  (high-to-low transition).
- OE:** Output Enable. Timing parameters include  $t_{OE}$  (high pulse width),  $t_{OE}$  (high-to-low transition),  $t_{OE}$  (high-to-low transition), and  $t_{OE}$  (high-to-low transition).
- U I/O:** User Input/Output. Timing parameters include  $t_{I/O}$  (high pulse width),  $t_{I/O}$  (high-to-low transition),  $t_{I/O}$  (high-to-low transition), and  $t_{I/O}$  (high-to-low transition).
- Data in:** Data bus for data input. Timing parameters include  $t_{DI}$  (high-to-low transition),  $t_{DI}$  (high-to-low transition), and  $t_{DI}$  (high-to-low transition).
- Data out:** Data bus for data output. Timing parameters include  $t_{DO}$  (high-to-low transition),  $t_{DO}$  (high-to-low transition), and  $t_{DO}$  (high-to-low transition).

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### Hyper Page Mode (EDO) Read Cycle



**Remark** In the hyper page mode (EDO), read, write and read modify write cycles are available for each of the consecutive  $\overline{\text{CAS}}$  cycles within the same  $\overline{\text{RAS}}$  cycle.

The diagram illustrates the timing relationships between several control and data signals during memory access operations. The signals shown are:

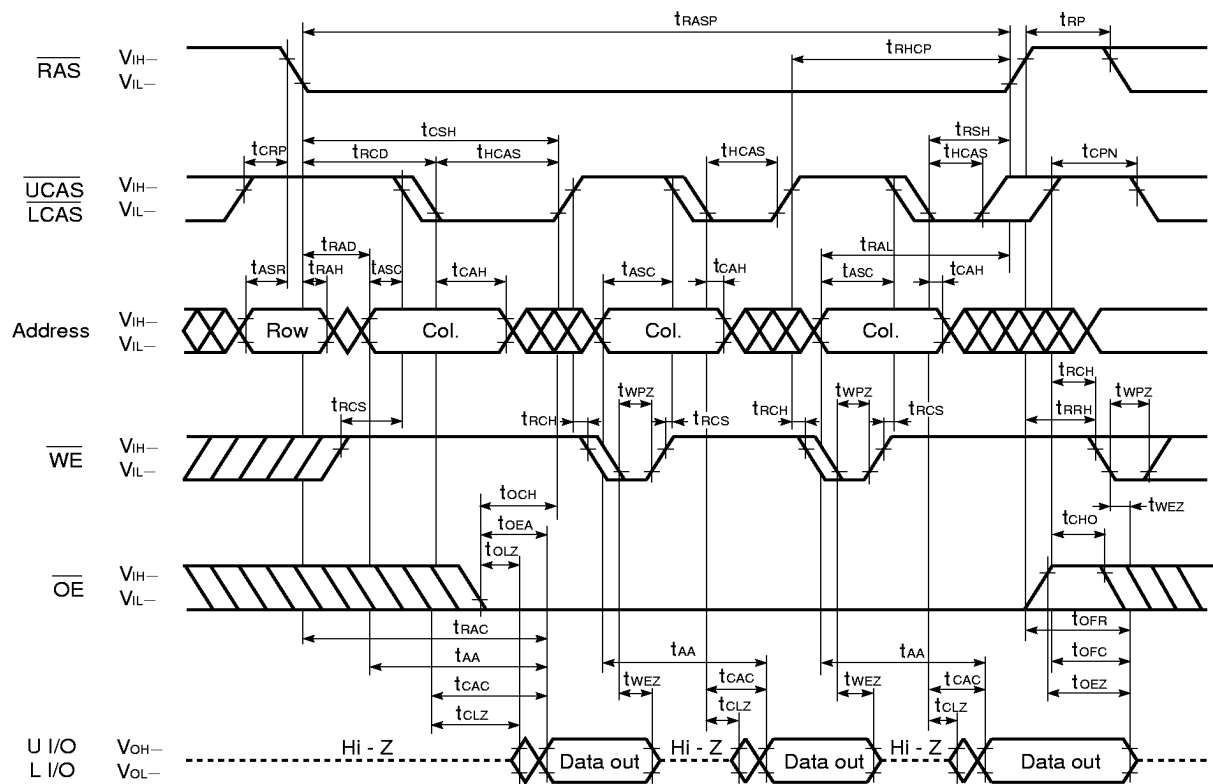
- RAS**: Row Address Strobe, active low.
- UCAS**: Upper Chip Address Strobe, active low.
- LCAS**: Lower Chip Address Strobe, active low.
- Address**: Bus address signal, showing Row and Column cycles.
- WE**: Write Enable, active low.
- OE**: Output Enable, active low.
- U I/O**: Upper Data Bus, showing Data out and Hi-Z states.
- L I/O**: Lower Data Bus, showing Data out and Hi-Z states.

Key timing parameters labeled include:

- $t_{RASP}$ ,  $t_{RHCP}$ ,  $t_{RP}$
- $t_{CRP}$ ,  $t_{CSH}$ ,  $t_{RCD}$ ,  $t_{HCAS}$ ,  $t_{HPC}$ ,  $t_{RSH}$ ,  $t_{HCAS}$ ,  $t_{CPN}$
- $t_{CP}$ ,  $t_{MRH}$ ,  $t_{RAD}$ ,  $t_{ASR}$ ,  $t_{RAH}$ ,  $t_{ASC}$ ,  $t_{CAH}$ ,  $t_{ASC}$ ,  $t_{CAH}$ ,  $t_{ASC}$ ,  $t_{CAH}$ ,  $t_{OFR}$ ,  $t_{OFC}$
- $t_{RCH}$ ,  $t_{RRH}$ ,  $t_{WPZ}$ ,  $t_{CHO}$ ,  $t_{WEZ}$
- $t_{TOEA}$ ,  $t_{ACP}$ ,  $t_{TAA}$ ,  $t_{CAC}$ ,  $t_{TOEZ}$
- $t_{TRAC}$ ,  $t_{TAA}$ ,  $t_{CAC}$ ,  $t_{CLZ}$ ,  $t_{DHC}$

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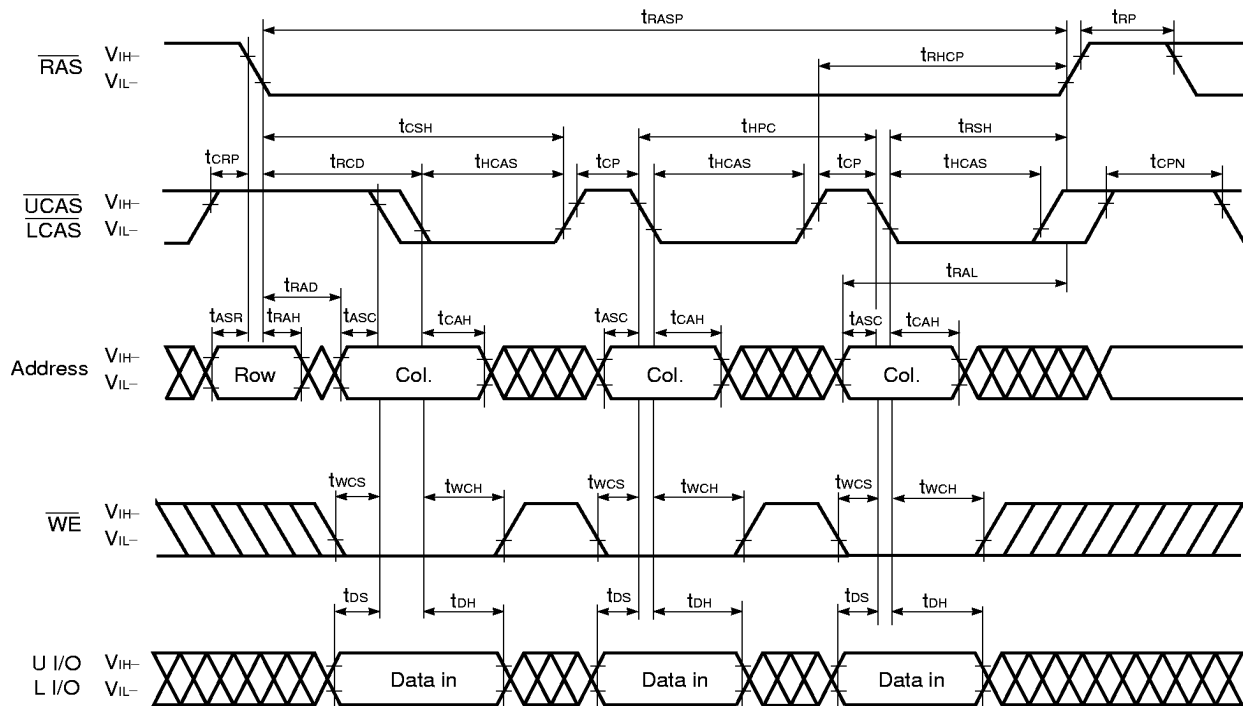
### Hyper Page Mode (EDO) Read Cycle ( $\overline{\text{WE}}$ Control)



**Remark** In the hyper page mode (EDO), read, write and read modify write cycles are available for each of the consecutive  $\overline{\text{CAS}}$  cycles within the same  $\overline{\text{RAS}}$  cycle.

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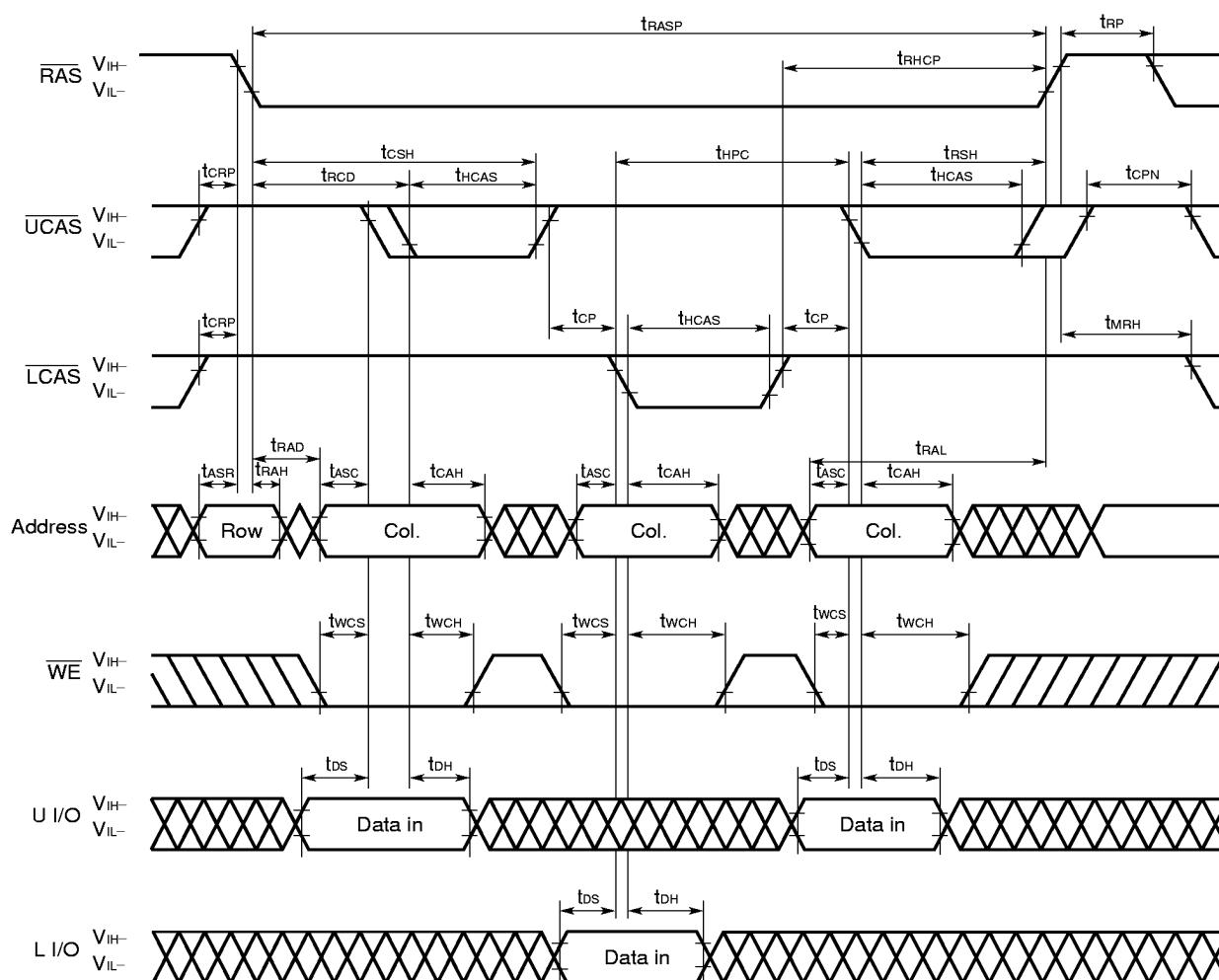
# Hyper Page Mode (EDO) Early Write Cycle



**Remarks** 1.  $\overline{OE}$ : Don't care

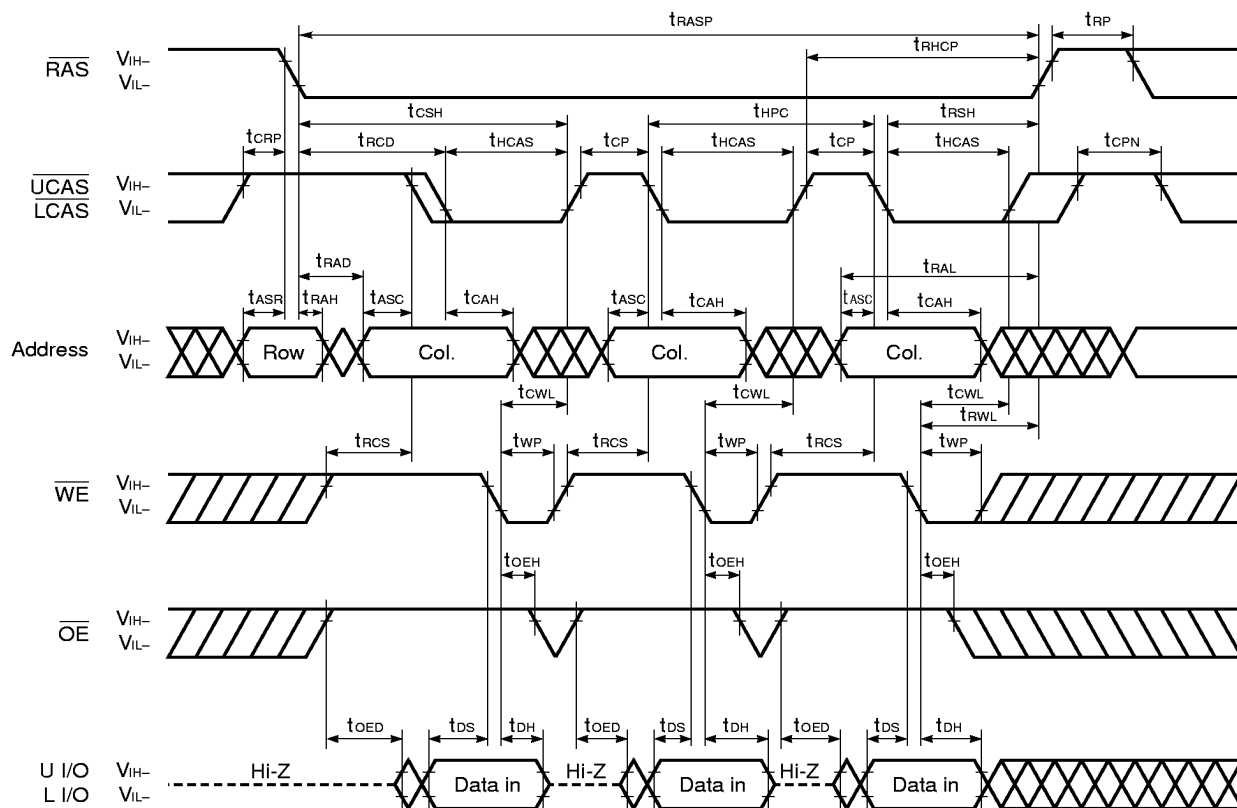
2. In the hyper page mode (EDO), read, write and read modify write cycles are available for each of the consecutive  $\overline{CAS}$  cycles within the same  $\overline{RAS}$  cycle.

## Hyper Page Mode (EDO) Byte Early Write Cycle



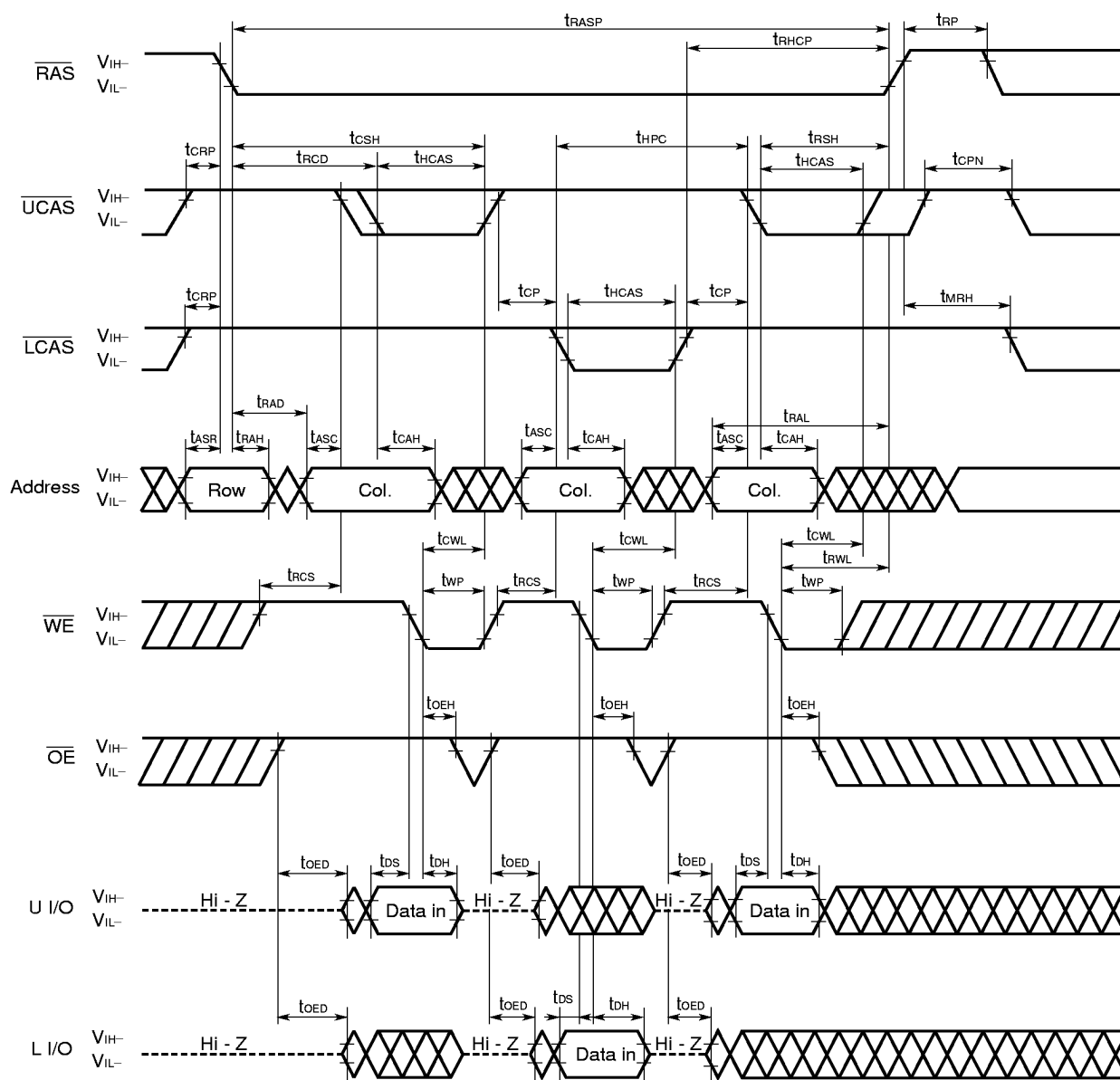
- Remarks**
1.  $\overline{OE}$ : Don't care
  2. In the hyper page mode (EDO), read, write and read modify write cycles are available for each of the consecutive  $\overline{CAS}$  cycles within the same  $\overline{RAS}$  cycle.
  3. This cycle can be used to control either  $\overline{UCAS}$  or  $\overline{LCAS}$  only. Or, it can be used to control  $\overline{UCAS}$  or  $\overline{LCAS}$  simultaneously, or at random.

### Hyper Page Mode (EDO) Late Write Cycle



**Remark** In the hyper page mode (EDO), read, write and read modify write cycles are available for each of the consecutive  $\overline{\text{CAS}}$  cycles within the same  $\overline{\text{RAS}}$  cycle.

## Hyper Page Mode (EDO) Byte Late Write Cycle



- Remarks**
1. In the hyper page mode (EDO), read, write and read modify write cycles are available for each of the consecutive  $\overline{\text{CAS}}$  cycles within the same  $\overline{\text{RAS}}$  cycle.
  2. This cycle can be used to control either  $\overline{\text{UCAS}}$  or  $\overline{\text{LCAS}}$  only. Or, it can be used to control  $\overline{\text{UCAS}}$  or  $\overline{\text{LCAS}}$  simultaneously, or at random.

The diagram illustrates the timing relationships between various control and data signals during memory operations. The signals shown are:

- RAS**: Row Address Strobe, active low.
- CAS**: Column Address Strobe, active low.
- Address**: Memory address bus, shown with Row and Column phases.
- WE**: Write Enable, active low.
- OE**: Output Enable, active low.
- I/O**: Data bus, shown as output (out) and input (in).

Key timing parameters labeled include:

- $t_{RAS}$ ,  $t_{CRP}$ ,  $t_{RCD}$ ,  $t_{HPRWC}$ ,  $t_{tCAS}$ ,  $t_{CP}$ ,  $t_{tCAS}$ ,  $t_{CPN}$
- $t_{RAD}$ ,  $t_{ASR}$ ,  $t_{RAH}$ ,  $t_{ASC}$ ,  $t_{CAH}$ ,  $t_{ASC}$ ,  $t_{CAH}$ ,  $t_{RAL}$
- $t_{RCS}$ ,  $t_{TRD}$ ,  $t_{AWD}$ ,  $t_{CWL}$ ,  $t_{ACP}$ ,  $t_{CPWD}$ ,  $t_{TWP}$ ,  $t_{RCSD}$ ,  $t_{CWD}$ ,  $t_{TCWL}$ ,  $t_{TCPWD}$ ,  $t_{TWL}$ ,  $t_{TRWL}$
- $t_{AAC}$ ,  $t_{CAC}$ ,  $t_{OEA}$ ,  $t_{TOEH}$ ,  $t_{AA}$ ,  $t_{OEZ}$ ,  $t_{OLZ}$
- $t_{DS}$ ,  $t_{DH}$

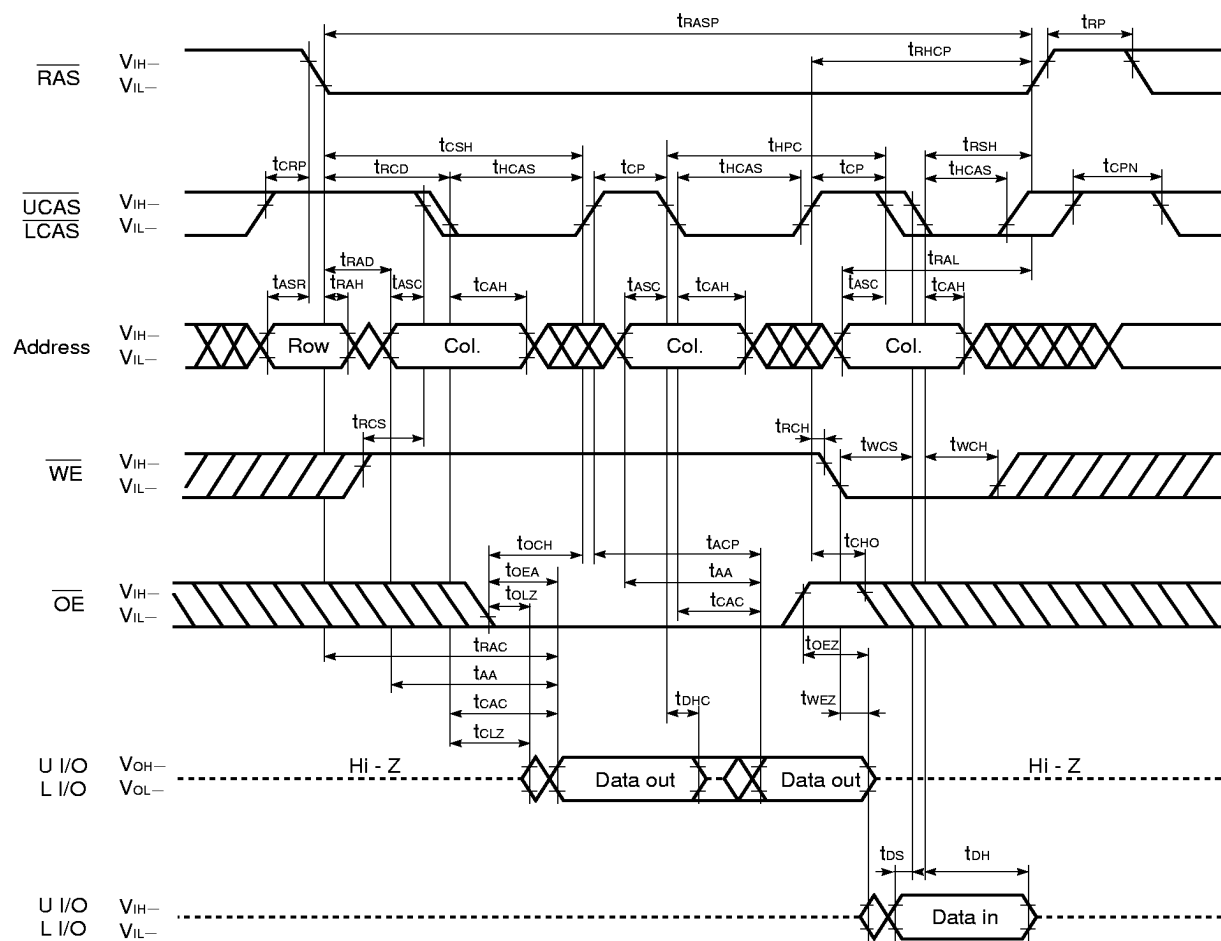
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The timing diagram illustrates the sequence of signals for the 64K1602 LCD module. The signals and their timing parameters are as follows:

- RAS**:  $V_{IH}$ ,  $V_{IL}$ . Timing:  $t_{CRP}$ ,  $t_{RCD}$ ,  $t_{HPRWC}$ ,  $t_{HCAS}$ ,  $t_{CPN}$ ,  $t_{MRH}$ .
- UCAS**:  $V_{IH}$ ,  $V_{IL}$ . Timing:  $t_{CRP}$ ,  $t_{RCD}$ ,  $t_{HPRWC}$ ,  $t_{HCAS}$ ,  $t_{CPN}$ .
- LCAS**:  $V_{IH}$ ,  $V_{IL}$ . Timing:  $t_{CRP}$ ,  $t_{RCD}$ ,  $t_{HPRWC}$ ,  $t_{HCAS}$ ,  $t_{CPN}$ .
- Address**:  $V_{IH}$ ,  $V_{IL}$ . Timing:  $t_{ASR}$ ,  $t_{RAH}$ ,  $t_{ASC}$ ,  $t_{CAH}$ ,  $t_{RWD}$ ,  $t_{AWD}$ ,  $t_{CWL}$ ,  $t_{RCS}$ ,  $t_{CWD}$ ,  $t_{WP}$ ,  $t_{RAC}$ ,  $t_{AA}$ ,  $t_{CAC}$ ,  $t_{OEH}$ ,  $t_{OEA}$ ,  $t_{CLZ}$ ,  $t_{OLZ}$ ,  $t_{OEZ}$ .
- WE**:  $V_{IH}$ ,  $V_{IL}$ . Timing:  $t_{ASR}$ ,  $t_{RAH}$ ,  $t_{ASC}$ ,  $t_{CAH}$ ,  $t_{RWD}$ ,  $t_{AWD}$ ,  $t_{CWL}$ ,  $t_{RCS}$ ,  $t_{CWD}$ ,  $t_{WP}$ ,  $t_{RAC}$ ,  $t_{AA}$ ,  $t_{CAC}$ ,  $t_{OEH}$ ,  $t_{OEA}$ ,  $t_{CLZ}$ ,  $t_{OLZ}$ ,  $t_{OEZ}$ .
- OE**:  $V_{IH}$ ,  $V_{IL}$ . Timing:  $t_{ASR}$ ,  $t_{RAH}$ ,  $t_{ASC}$ ,  $t_{CAH}$ ,  $t_{RWD}$ ,  $t_{AWD}$ ,  $t_{CWL}$ ,  $t_{RCS}$ ,  $t_{CWD}$ ,  $t_{WP}$ ,  $t_{RAC}$ ,  $t_{AA}$ ,  $t_{CAC}$ ,  $t_{OEH}$ ,  $t_{OEA}$ ,  $t_{CLZ}$ ,  $t_{OLZ}$ ,  $t_{OEZ}$ .
- I/O**:  $V_{OH}$ ,  $V_{OL}$ . Timing:  $t_{ASR}$ ,  $t_{RAH}$ ,  $t_{ASC}$ ,  $t_{CAH}$ ,  $t_{RWD}$ ,  $t_{AWD}$ ,  $t_{CWL}$ ,  $t_{RCS}$ ,  $t_{CWD}$ ,  $t_{WP}$ ,  $t_{RAC}$ ,  $t_{AA}$ ,  $t_{CAC}$ ,  $t_{OEH}$ ,  $t_{OEA}$ ,  $t_{CLZ}$ ,  $t_{OLZ}$ ,  $t_{OEZ}$ .

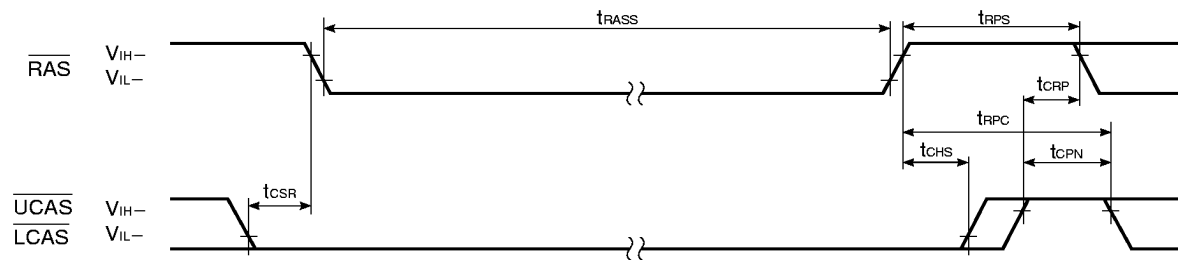
- Remarks**
1. In the hyper page mode (EDO), read, write and read modify write cycles are available for each of the consecutive  $\overline{\text{CAS}}$  cycles within the same  $\overline{\text{RAS}}$  cycle.
  2. This cycle can be used to control either  $\overline{\text{UCAS}}$  or  $\overline{\text{LCAS}}$  only. Or, it can be used to control  $\overline{\text{UCAS}}$  or  $\overline{\text{LCAS}}$  simultaneously, or at random.

# Hyper Page Mode (EDO) Read and Write Cycle



**Remark** In the hyper page mode (EDO), read, write and read modify write cycles are available for each of the consecutive  $\overline{\text{CAS}}$  cycles within the same  $\overline{\text{RAS}}$  cycle.

# **CAS Before RAS Self Refresh Cycle (Only for the $\mu$ PD42S16165L)**



**Remark** Address,  $\overline{WE}$ ,  $\overline{OE}$ : Don't care L I/O, U I/O: Hi-Z

## **Cautions on Use of CAS Before RAS Self Refresh**

CAS before RAS self refresh can be used independently when used in combination with distributed CAS before RAS long refresh; However, when used in combination with burst CAS before RAS long refresh or with long RAS only refresh (both distributed and burst), the following cautions must be observed.

### **(1) Normal Combined Use of CAS Before RAS Self Refresh and Burst CAS Before RAS Long Refresh**

When CAS before RAS self refresh and burst CAS before RAS long refresh are used in combination, please perform CAS before RAS refresh 4,096 times within a 64 ms interval just before and after setting CAS before RAS self refresh.

### **(2) Normal Combined Use of CAS Before RAS Self Refresh and Long RAS Only Refresh**

When CAS before RAS self refresh and RAS only refresh are used in combination, please perform RAS only refresh 4,096 times within a 64 ms interval just before and after setting CAS before RAS self refresh.

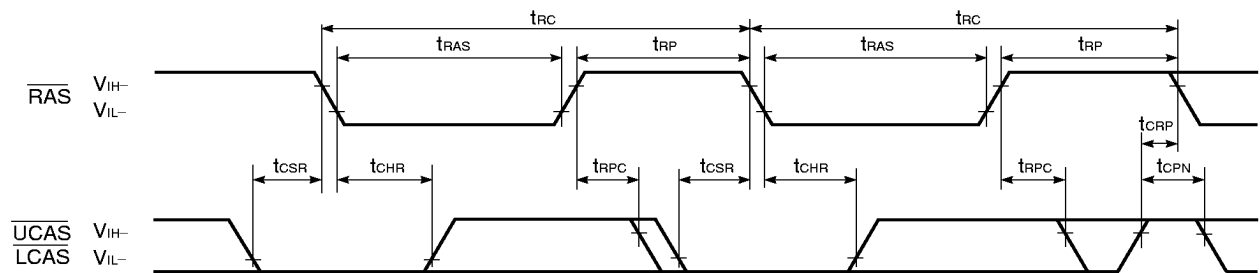
### **(3) If $t_{RASS(MIN.)}$ is not satisfied at the beginning of CAS before RAS self refresh cycles ( $t_{RAS} < 100 \mu s$ ), CAS before RAS refresh cycles will be executed one time.**

If  $10 \mu s < t_{RAS} < 100 \mu s$ , RAS precharge time for CAS before RAS self refresh ( $t_{RPS}$ ) is applied.

And refresh cycles (4,096/128 ms) should be met.

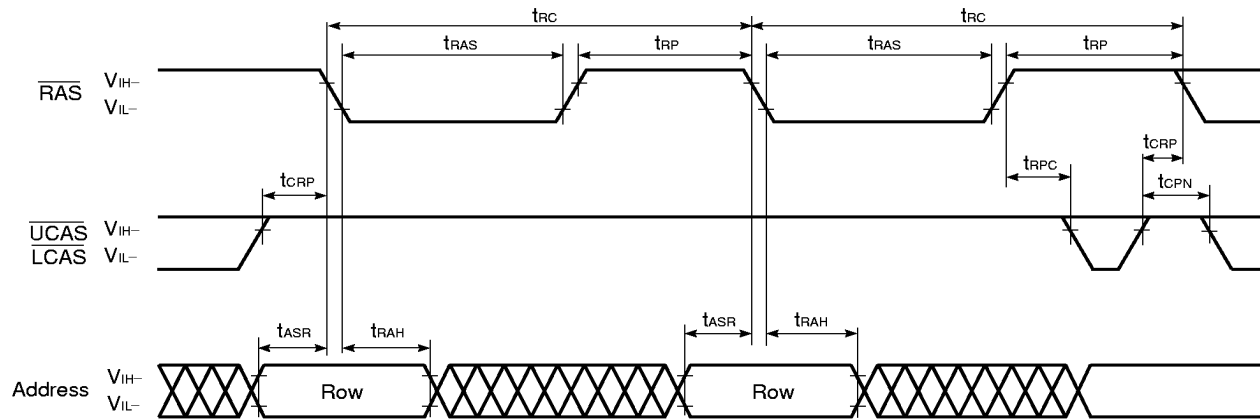
For details, please refer to **How to use DRAM** User's Manual.

**CAS Before RAS Refresh Cycle**



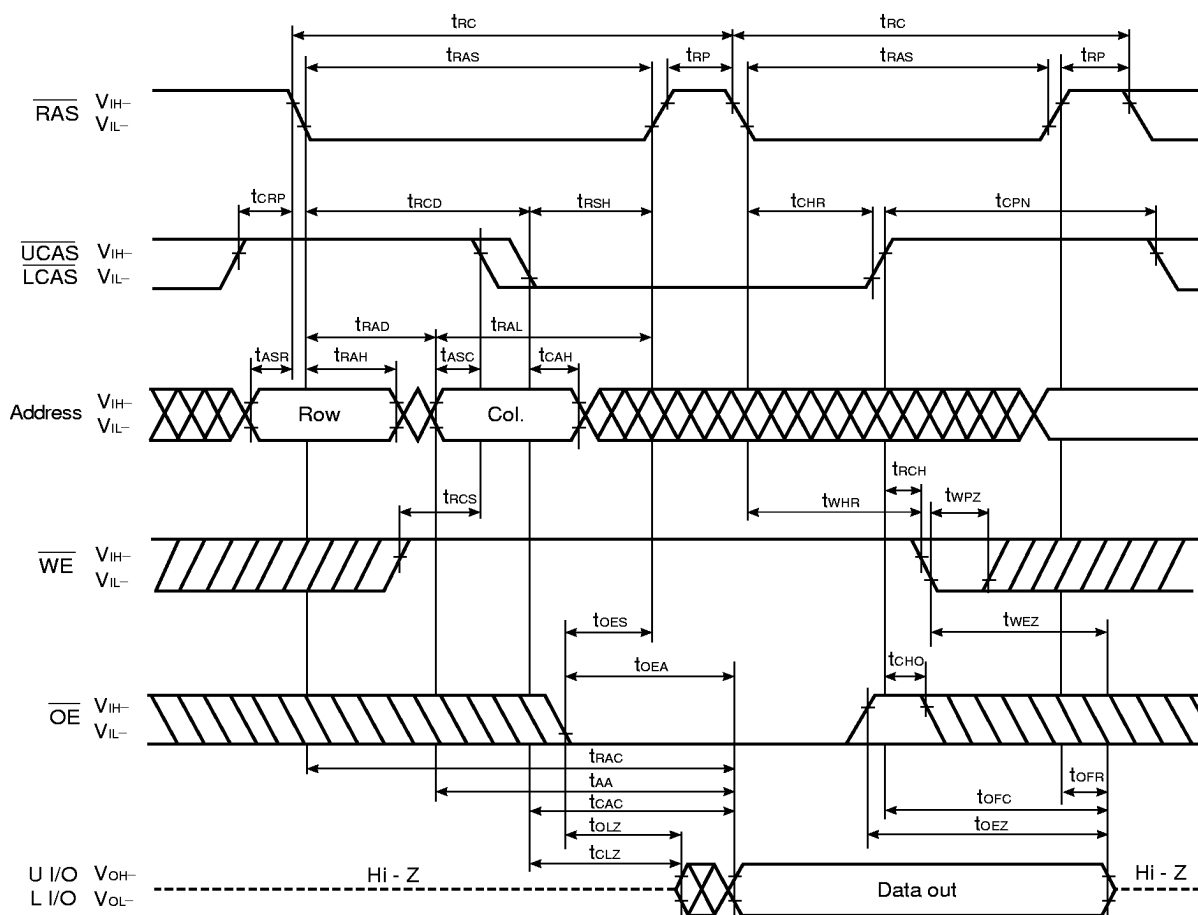
**Remark** Address,  $\overline{\text{WE}}$ ,  $\overline{\text{OE}}$ : Don't care L I/O, U I/O: Hi-Z

**RAS Only Refresh Cycle**

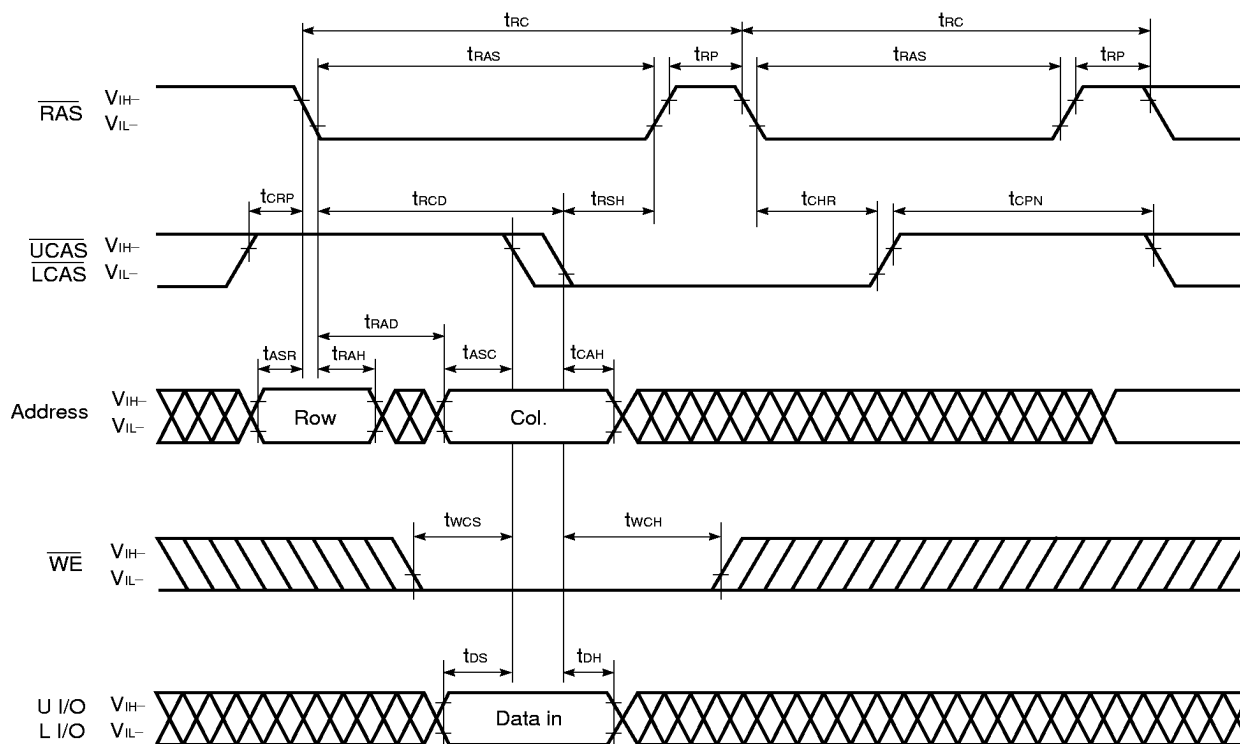


**Remark**  $\overline{\text{WE}}$ ,  $\overline{\text{OE}}$ : Don't care L I/O, U I/O: Hi-Z

# Hidden Refresh Cycle (Read)



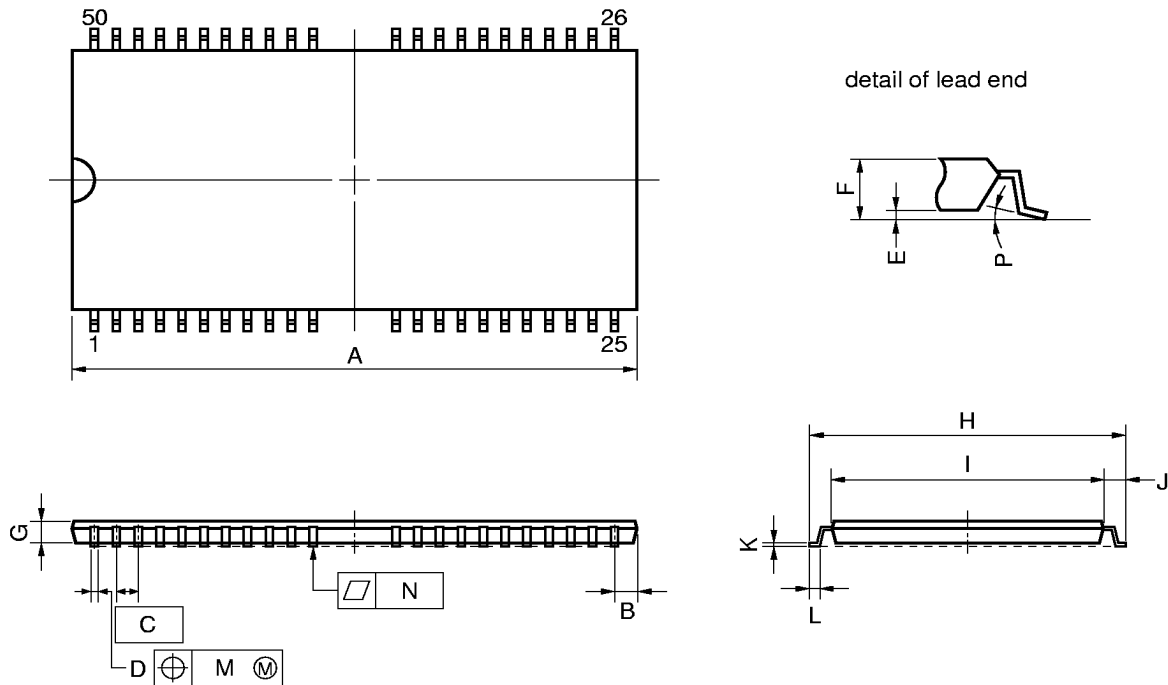
# Hidden Refresh Cycle (Write)



**Remark**  $\overline{\text{OE}}$ : Don't care

Package Drawings

50PIN PLASTIC TSOP(II) (400 mil)

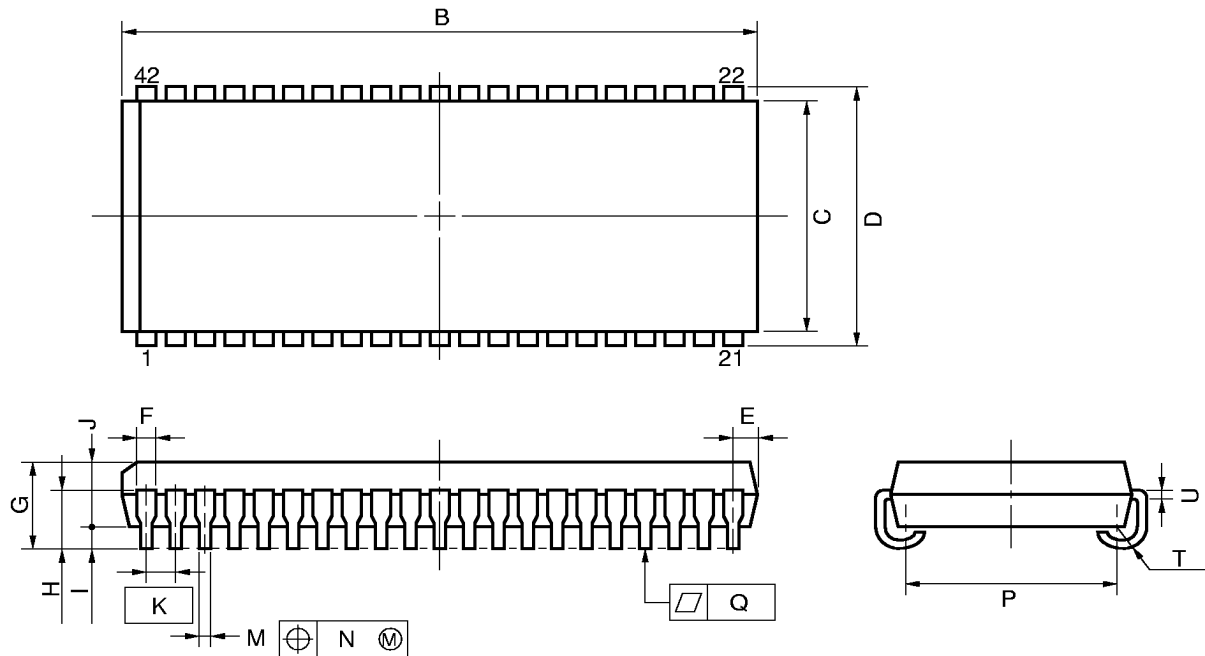


**NOTE**  
Each lead centerline is located within 0.13 mm (0.005 inch) of its true position (T.P.) at maximum material condition.

| ITEM | MILLIMETERS                               | INCHES                                    |
|------|-------------------------------------------|-------------------------------------------|
| A    | 21.17 MAX.                                | 0.834 MAX.                                |
| B    | 1.0 MAX.                                  | 0.040 MAX.                                |
| C    | 0.8 (T.P.)                                | 0.031 (T.P.)                              |
| D    | 0.32 <sup>+0.08</sup> <sub>-0.07</sub>    | 0.013±0.003                               |
| E    | 0.1±0.05                                  | 0.004±0.002                               |
| F    | 1.2 MAX.                                  | 0.048 MAX.                                |
| G    | 0.97                                      | 0.038                                     |
| H    | 11.76±0.2                                 | 0.463±0.008                               |
| I    | 10.16±0.1                                 | 0.400±0.004                               |
| J    | 0.8±0.2                                   | 0.031 <sup>+0.009</sup> <sub>-0.008</sub> |
| K    | 0.145 <sup>+0.025</sup> <sub>-0.015</sub> | 0.006±0.001                               |
| L    | 0.5±0.1                                   | 0.020 <sup>+0.004</sup> <sub>-0.005</sub> |
| M    | 0.13                                      | 0.005                                     |
| N    | 0.10                                      | 0.004                                     |
| P    | 3° <sup>+7°</sup> <sub>-3°</sub>          | 3° <sup>+7°</sup> <sub>-3°</sub>          |

S50G5-80-7JF4

42 PIN PLASTIC SOJ (400 mil)



**NOTE**

Each lead centerline is located within 0.12 mm (0.005 inch) of its true position (T.P.) at maximum material condition.

P42LE-400A

| ITEM | MILLIMETERS                            | INCHES                                    |
|------|----------------------------------------|-------------------------------------------|
| B    | 27.56 <sup>+0.2</sup> <sub>-0.35</sub> | 1.085 <sup>+0.008</sup> <sub>-0.014</sub> |
| C    | 10.16                                  | 0.400                                     |
| D    | 11.18±0.2                              | 0.440±0.008                               |
| E    | 1.08±0.15                              | 0.043 <sup>+0.006</sup> <sub>-0.007</sub> |
| F    | 0.74                                   | 0.029                                     |
| G    | 3.5±0.2                                | 0.138±0.008                               |
| H    | 2.545±0.2                              | 0.100±0.008                               |
| I    | 0.8 MIN.                               | 0.031 MIN.                                |
| J    | 2.6                                    | 0.102                                     |
| K    | 1.27 (T.P.)                            | 0.050 (T.P.)                              |
| M    | 0.40±0.10                              | 0.016 <sup>+0.004</sup> <sub>-0.005</sub> |
| N    | 0.12                                   | 0.005                                     |
| P    | 9.4±0.20                               | 0.370±0.008                               |
| Q    | 0.10                                   | 0.004                                     |
| T    | R 0.85                                 | R 0.033                                   |
| U    | 0.20 <sup>+0.10</sup> <sub>-0.05</sub> | 0.008 <sup>+0.004</sup> <sub>-0.002</sub> |

## ★ Recommended Soldering Conditions

The following conditions (see tables below and next page) must be met for soldering conditions of the  $\mu$ PD42S16165L, 4216165L.

For more details, refer to our document "SEMICONDUCTOR DEVICE MOUNTING TECHNOLOGY MANUAL" (C10535E).

Please consult with our sales offices in case other soldering process is used, or in case the soldering is done under different conditions.

## Types of Surface Mount Device

$\mu$ PD42S16165LG5-7JF, 4216165LG5-7JF: 50-pin plastic TSOP (II) (400 mil)

| Soldering process      | Soldering conditions                                                                                                                                                                                                                                   | Symbol     |
|------------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------------|
| Infrared ray reflow    | Peak temperature of package surface: 235 °C or lower,<br>Reflow time: 30 seconds or less (210 °C or higher),<br>Number of reflow processes: MAX. 3<br>Exposure limit: 7 days <sup>Note</sup><br>(10 hours pre-baking is required at 125 °C afterwards) | IR35-107-3 |
| VPS                    | Peak temperature of package: 215 °C or lower,<br>Reflow time: 40 seconds or less (200 °C or higher),<br>Number of reflow processes: MAX. 3<br>Exposure limit: 7 days <sup>Note</sup><br>(10 hours pre-baking is required at 125 °C afterwards)         | VP15-107-3 |
| Partial heating method | Terminal temperature: 300 °C or lower,<br>Time: 3 seconds or lower (Per side of the package).                                                                                                                                                          | —          |

**Note** Exposure limit before soldering after dry-pack package is opened.  
Storage conditions: 25 °C and relative humidity at 65 % or less.

**Caution** Do not apply more than one soldering method at any one time, except for "Partial heating method".

μ PD42S16165LLE, 4216165LLE: 42-pin plastic SOJ (400 mil)

| Soldering process      | Soldering conditions                                                                                                                                                                                                                                   | Symbol     |
|------------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|------------|
| Infrared ray reflow    | Peak temperature of package surface: 235 °C or lower,<br>Reflow time: 30 seconds or less (210 °C or higher),<br>Number of reflow processes: MAX. 3<br>Exposure limit: 7 days <sup>Note</sup><br>(20 hours pre-baking is required at 125 °C afterwards) | IR35-207-3 |
| VPS                    | Peak temperature of package: 215 °C or lower,<br>Reflow time: 40 seconds or less (200 °C or higher),<br>Number of reflow processes: MAX. 3<br>Exposure limit: 7 days <sup>Note</sup><br>(20 hours pre-baking is required at 125 °C afterwards)         | VP15-207-3 |
| Partial heating method | Terminal temperature: 300 °C or lower,<br>Time: 3 seconds or less (Per side of the package).                                                                                                                                                           | —          |

**Note** Exposure limit before soldering after dry-pack package is opened.  
Storage conditions: 25 °C and relative humidity at 65 % or less.

**Caution** Do not apply more than one soldering method at any one time, except for “Partial heating method”.